SDH Concept Guide

HP 37717C Communications Performance Analyzer

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HP 37717C Communications Performance Analyzer

About This Book

The information on SDH testing in this book covers the following subjects:

- An Introduction to SDH, the SDH modules and their features.
- Measurement examples.
- Measurement result definitions
- Logging messages
- Self test error codes

For some operations and measurements, information from one of the associated books listed at the rear of this guide may be required.

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Introduction to SDH Testing

Information on SDH in general and the SDH test features of the HP 37717C.

Introduction to SDH

Synchronous Digital Heirarchy (SDH) is an international standard (ETSI) for high speed synchronous optical telecommunications networks.

The concept of a synchronous transport system, based on SDH standards, goes beyond the basic needs of a point to point transmission system. It includes the requirements of telecommunications networking - switching, transmission and network control. These capabilities allow SDH to be used in all three traditional network application areas - Local Network, Inter-exchange Network and Long Haul Network - thus providing a unified telecommunication network structure.

The SDH standards are based on the principle of direct synchronous multiplexing. This means that individual tributary signals (Payload) may be multiplexed directly into a higher rate SDH signal without intermediate stages of multiplexing. SDH network elements, even those supplied by different manufacturers, can be interconnected directly giving cost and equipment savings.

SDH is capable of transporting all the common tributary signals E1 (2.048 Mb/s), E3 (34.368 Mb/s), E4 (139.264 Mb/s), DS1 (1.544 Mb/s) and DS3 (44.736 Mb/s) currently in use. In addition SDH has the flexibility to readily accommodate any new types of service which are being introduced for example (ATM) or which may be required in the future. Approximately 5% of the SDH signal structure (Overhead) is reserved for network management and maintenance.

This means that SDH can be deployed as an overlay to the existing network thus providing enhanced network flexibility.

The HP 37717C provides comprehensive testing of both payload and overhead at electrical and optical SDHinterfaces.

37717C SDH Options

Option A3R [A3S] SDH Generation and Analysis page 4

SDH generation and analysis with STM-0 and STM-1 electrical interfaces, Option A3R.

Additional SDH interface capability is provided by the following Options::

STM-1 Optical Interface, Option UH1.

STM-0, STM-1 and STM-4 optical interfaces at 1310nm, Option 131.

STM-0, STM-1 and STM-4 optical interfaces at 1310nm and 1550nm, Option 130.

STM-0, STM-1, and STM4 binary interfaces, Option 0YH

Option A3R [A3S] SDH Generation and Analysis

Option A3R [A3S] provides STM-0 and STM-1 Electrical interfaces.

When Option UH1 is fitted STM-1 Optical interfaces are provided.

When Option 130 or 131 is fitted STM-1 and STM-4 optical interfaces are provided.

When STM1-1 Optical is selected, the STM-1 electrical output is also active.

The THRU mode capability allows you to overwrite the TU-2, TU-3, AU-3, TU12 and AU-4 payloads and the section overhead of the incoming STM-0/STM-1/STM-4 signal.

Frequency offset of the SDH signal of 999 ppm is available.

Bulk Filled and Mixed payloads are available. If Option UKJ, Structured PDH, is fitted, DS1 and DS3 payloads are available and a 2 Mb/s, 34 Mb/s and 140 Mb/s Insert Port is provided. Bit errors can be added to the payload.Errors & Alarms can be added to the SDH signal.

AU and TU Pointer Movements can be added to the SDH signal and a Graphical display of Pointer activity is available.

Section and path Overhead bytes are user programmable and can be monitored and displayed in Hexadecimal or as 8 bit bytes. Selected overhead bytes can be transmitted with a programmed sequence of data. Receive sequences can be captured and displayed. K4 and V5 overhead bytes can be accessed.

Allows BER testing of section and path overhead bytes. Allows testing of MSP Linear and Ring architectures. DCC Drop and Insert capability is included.

Allows Protection Switch time testing if Option UKJ, Structured PDH, is fitted.

Optical Power measurement is available. Optical Clock stress capability at STM-1 and STM-4 is included. Provides SDH Alarm Scan and Tributary Scan.





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SDH Testing

This Chapter gives examples of the instrument operation in typical SDH test applications.

Add/Drop Multiplexer Testing

Application

The insertion of tributary signals into the Add/Drop multiplexer, which are then mapped into the SDH signal, should take place without introducing errors. The insertion and mapping process is tested by adding a test pattern to the tributary inserted at the tributary insert port. At the SDH side of the Add/Drop multiplexer the tributary is demapped by the HP 37717C Communications Performance Analyzer. By using the Optical Splitter, at the optical side of the Add/Drop multiplexer, the Add/Drop multiplexer need not be taken out of service. A Bit error rate (BER) test is performed on the recovered tributary test pattern to determine whether errors have been introduced by the Add/Drop multiplexer.

Default (Known State) Settings

It is advisable to set the HP 37717C to a known state before setting up a measurement. This clears all previous settings and provides a clearly defined instrument state. The default settings are set by selecting **OTHER STORED SETTINGS** STORED SETTING NUMBER 0 and pressing **RECALL**

Add/Drop Multiplexer Testing Test Setup Procedure

The following Options must be fitted to the HP 37717C to perform this test :

- UKJ [USA]or UKK [USB] PDH Module
- A3R [A3S] SDH Module
- 130 or 131 STM-0/1/4 Optical Interface

In this setup a 2 Mb/s payload, containing a test pattern, is inserted at the tributary insert port of the Add/Drop multiplexer multiplexer. A portion of the STM4 Optical signal is tapped off by the Optical Splitter (approx 10%) and the 2 Mb/s tributary is demapped by the HP 37717C Communications Performance Analyzer.

An Error measurement is performed on the demapped 2 Mb/s tributary test pattern.

A SINGLE test period of 24 HOURS is used and the internal printer is enabled to record results and alarms.

The HP 37717C Communications Performance Analyzer GRAPHICS function is enabled. The graphical results can be viewed on the **GRAPH** display



1. Connect the HP 37717C to the network equipment and set the **OTHER SETTINGS CONTROL** TRANSMITTER AND RECEIVER to INDEPENDENT.

Changes made on the **TRANSMIT** display will not affect the **RECEIVE** display and changes made on the **RECEIVE** display will not affect the **TRANSMIT** display.

2. Set up the **TRANSMIT** display as shown opposite.

The PAYLOAD TYPE determines the Framing. .

TRANSMITTER OUTPUT	E PDH Test Unction	3
SIGNAL	[2 Mb/s]
CLOCK SYNC [INTERNAL] TERMINATION LINE CODE FREQUENCY OFFSET	E 750 UNBAL E HDB3 E OFF]]
PAYLOAD TYPE PATTERN PRBS POLARITY 2M CAS ABCD BITS	E PCM30CRC E 2^11-1 PRB E INV] NON-I E 1111	ן 1 1 1 1
STATUS:		MULTIPLE WINDOW

3. Set up the **RECEIVE** display as shown opposite.

RECEIVER IN SDH STRL PRYL SIGNAL [ST	PUT ICT'D TES ORD FUNCT M-4 OPT]	E SDH T OVERHEAD ION MONITOR	3	
MAPPING Channel Tu payload Pattern C2	C RU-4 STM-1 C1J ^11-1 PRBS	J [TU-12 [RSYNC 2M6, TUG3 TUG2 [1] [1] [PCMSOCRC J [INVERT] NOI	/s] TU [1] I-ITU	
STATUS:				MULTIPLE WINDOW

Continuity Check

Before running the test carry out a continuity test to verify the measurement path.

1. Set up the **RESULTS** display as shown opposite.

2. Press **RUN/STOP** to start a measurement.

3. Press error add -**SINGLE** three times and check that the errors are recorded on the -**RESULTS** display.

3. Check that the errors are recorded on the **RESULTS** display.

4. Press **RUN/STOP** to stop the measurement.

Select the	required	logging	DEVICE and
set up the	OTHER	display,	LOGGING
function, a	as shown	opposite	

FUNCTION	[LOGGING]	
LOGGING SETUP	[CONTROL]	
LOGGING LOGGING PERIOD	E ON 3 E 1 HOUR 3	
RESULTS LOGGED WHEN CONTENT	[SELECTED] I PERIOD EC>O [ER & ANAL] I BER & CIMU	
LOG ERROR SECONDS LOG AT END OF TES	T ALL RESULTS	
LOG ON DEMAND	RESULTS	
STATUS:	_	
HLWHYS PERIOD EC > 0		MULTIPLE WINDOW

RESULTS	S [PDH PAYLOAD Frs crc 2 Mb/s	JE CUMULATIVE REBE]	
віт	EC			
BIT	ER			
ELAPSEI) TIME			
STATUS:				MULTIPLE
				WINDOW

Start the Add/Drop Multiplexer Test

1. Set up the **RESULTS** display as shown opposite. If you do not require stored graphics results select STORAGE [OFF].

Graphics results can be stored to the instrument store - INTERNAL or to DISK.

SHORT TERM PERIOD need only be set if it is intended to view Short Term results.

2. Press **RUN/STOP** to start the measurement.

STATUS:	SEC	1 MIN	15 MIN	1 HR	MULTI
GRAPH STORAGE		15 MIN RES INTERNAL	OL 'N]	
SHORT TERM PE TEST TIMING	RIODC	1 SECOND SINGLE]	E 24 HOURS]	

The measurement results and alarms are available on the **RESULTS** display during the test period.

The graphical measurement results and alarms are stored in non volatile memory for viewing later on the GRAPH display.

The test can be halted at any time by pressing **RUN/STOP**

L	C BIT		
EC ES EFS SES UNAU DEG MIN CODE ES ELAPSED TIME	AnD ES	2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2 2	
STATUS:	IS PDF	0595	

At the End of the Test (Add/Drop Multiplexer Testing)

- The Date and Time the test started and the instrument setup are logged To the selected logging device.
- Results are logged To the selected logging device at 1 hour intervals if the error count is greater than 0.
- Any alarms which occur during the test period will be logged To the selected logging device.
- At the end of the test period a complete set of cumulative results are logged To the selected logging device.
- A graphical record of the results during the test period can be viewed on the **GRAPH** display. If a printer option is fitted the graph results can be logged to a printer, at a later date.
- Results and Alarm summaries can be viewed on the **GRAPH** display.

The total graphics store capacity is normally 20,000 events. An event is the occurrence of an error or an alarm.

The resolution, determined by the selection made under STORAGE on the **RESULTS** display, affects the ZOOM capability when viewing the bar graphs. If 1 SECOND is selected all resolutions are available under ZOOM. If 1 MIN is selected only 1 MIN/BAR, 15 MINS/BAR and 60 MINS/BAR are available. If 15 MINS is selected only 15 MINS/BAR and 60 MINS/BAR are available. If 1 HOUR is selected only 60 MINS/BAR is available.

Up to 10 sets of graphical results can be stored. If an attempt is made to store more than 10 sets of results, then a first in first out policy is operated and the oldest set of results will be lost. If graphics are enabled and a test is run which exceeds the remaining storage capacity, then some previously stored graphical results will be lost.

To prevent accidental overwriting of previously stored results the graphics capability should be disabled, when graphical results are not required, by selecting STORAGE [OFF] on the **RESULTS**] display.

Alarm Stimulus/Response

Application

SDH Network elements transmit alarms in response to certain error/alarm conditions to advise upstream and downstream equipment that these conditions exist. If these alarms are not transmitted in the proper manner, at the proper time, degradations in service will occur.

Alarm testing entails transmitting an alarm signal from the Communications Performance Analyzer and monitoring the network equipment alarm indicators and the upstream or downstream signal for the correct response.

Default (Known State) Settings

It is advisable to set the HP 37717C to a known state before setting up a measurement. This clears all previous settings and provides a clearly defined instrument state. The default settings are set by selecting **OTHER STORED SETTINGS** STORED SETTING NUMBER 0 and pressing **RECALL**

Alarm Stimulus/Response Test Setup Procedure

The following options must be fitted to the HP 37717C to perform this test:

- A3R [A3S] SDH module
- UH1, STM-1 Optical interface or 130 or 131 STM-0/1/4 Optical interface

In this setup the Communications Performance Analyzer transmits MS-AIS Alarm (Line AIS) into the network. The network equipment alarm indicators are monitored for the appropriate alarms. The upstream signal is monitored for occurrences of MS-RDI. The downstream signal can be monitored for occurrences of AU-AIS.

A similar procedure can be used for testing all other SDH alarms. See the following tables.



SDH Alarms

Alarm	RSTI	E	MS	STE	Р	TE
	Down	Up	Down	Up	Down	Up
Loss Of Signal	MS-AIS	N/A	AU-AIS	MS-RDI	TU-AIS	LP-RDI
Loss Of Frame	MS-AIS	N/A	AU-AIS	MS-RDI	TU-AIS	LP-RDI
Loss Of Pointer	N/A	N/A	AU-AIS	MS-RDI	TU-AIS	LP-RDI
MS-AIS	N/A	N/A	AU-AIS	MS-RDI	TU-AIS	LP-RDI
MS-RDI	N/A	N/A	N/A	N/A	N/A	N/A

1. Set up the OTHER ; SETTINGS	FUNCTION [SETTINGS CONTROL]	
CONTROL display as shown opposite.	TRANSMITTER AND RECEIVER	
Any changes made on the TRANSMIT or	RECEIVER COUPLED TO TRANSMITTER	
RECEIVE display will affect the other.		
	STATUS:	
	INDEP- COUPLED ENDENT	MULTIPLE WINDOW
2. Set up the TRANSMIT ; SDH display as shown opposite.	TRANSMITTER OUTPUT C SDH J SUH STRUCT'P JITTER TEST OUERHEAD SIGNEL STAUCT'P JITTER FUNCTION SETUP SIGNEL STAUCT'P JITTER FUNCTION SETUP SIGNEL STAUCT'P JIO JITTERNAL JIO JITTERNAL NRPPING RU-4 [VC-4 J JIO JITTERNAL JIO 140H DFFSET [0 PPH J JIO JITTERNAL JIO JIO PAYLORD TYPE [UNFRAMED J JINTU J PATTERN [Z0*29-1 PRBS] [INVERT J JTU J STATUS: STATUS: J J J	NUE TPLE
3. Set up the TRANSMIT ; TEST FUNCTION display as shown opposite.	TRANSMITTER DUTPUT [SDH] SDH]ITTER TEST DUERNERD FUNCTION SETUP TEST FUNCTION [SOH] ERR & ALARM]	
The ERROR ADD TYPE selected does not	ERROR ADD TYPE [R1R2 FRAME] RATE [OFF]	

matter as long as RATE [OFF] is selected.

TRANSMITTER OUTPUT SDH JITTER TES FUNCT	E SDH T OVERHEAD ION SETUP	3
TEST FUNCTION [SDH	JE ERR & ALAR	MD
ERROR ADD TYPE RATE	[R1R2 FRAME [OFF]
ALARM TYPE	E MS AIS	
STATUS:		
NS HIS NS FERF L	DINTER AIS	MURE MULTIPLE

4. Set up the **RESULTS** display as shown opposite

SHORT TERM PERIOD need only be set if it is intended to view Short Term results

RESULTS [TIMING	CONTROL 3			
SHORT TERM PERIN TEST TIMING	DD [1 SECOND [MANUAL]		1	
GRAPH STORAGE	l off I internal			
CTRTUC.				
OFF 1 SEC RESOL	1 MIN N RESOL'N	15 MIN RESOL 'N	1 HR RESOL 'N	MULTIPLE WINDOW

Start the Alarm Stimulus/Response Test

1. Connect the Communications Performance Analyzer to the upstream port of the network equipment and press **RUN/STOP** on the HP 37717C.

2. Check that the network equipment registers MS-AIS and that MS-RDI alarm seconds are recorded on the **RESULTS** display.

ALARM SECONDS are displayed but any of the other results can be selected from the softkey menu without affecting the measurement

The MS-RDI indicator on the front panel in conjunction with $\fbox{SHOW HISTORY}$ will

also give an indication that the MS-RDI alarm has occurred.

RESULTS [SDH	IC ALARM SECONDS]
POMER LOSS LOS LOF OOF RU-LOP MS-RIS RU-RIS ELRPSED TIME	K1./K2 CHANGE NS-RDI HP-RDI H4-LOM TU-LOP TU-RIS LP-RDI
STATUS: Alarm Freq Seconds Uenc	POINTER POINTER MORE MULTIPLE VHLUES GRAPH MINDON

SDH Testing DCC Testing

DCC Testing

Application

The section overhead contains two Data Communication Channels (DCC), Regenerator Section DCC at 192 kb/s (overhead bytes D1- D3) and Multiplexer Section DCC at 576 kb/s (overhead bytes D4 - D12). The DCC communicates network management messages between network elements and the network controller via the operations support computer system.

If the DCC is not operating correctly these network management messages will be lost and degradations in network performance will pass unnoticed. This may result in a failure condition.

Full testing of the line and section DCC's can be carried out using a protocol analyzer connected via the HP 37717C Communications Performance Analyzer to the appropriate overhead bytes. At the far end the HP 37717C Communications Performance Analyzer can drop the selected DCC to the protocol analyzer allowing the DCC integrity to be analyzed.

If you do not have access to a protocol analyzer capable of handling SDH DCC protocol, the DCC integrity can be verified by a BER test using an HP 37732A, Digital Telecomm/Datacomm Analyzer.

Default (Known State) Settings

It is advisable to set the HP 37717C to a known state prior to setting up a measurement. This clears all previous settings and provides a clearly defined instrument state. The default settings are set by selecting **OTHER STORED SETTINGS** STORED SETTING NUMBER 0 and pressing **RECALL**

DCC Test Setup Procedure

Alarm Stimulus/Response Test Setup Procedure

The following options must be fitted to the HP 37717C to perform this test:

- A3R [A3S]- SDH module
- UH1, STM-1 Optical interface or 130 or 131 STM-0/1/4 Optical interface

IIn this procedure the HP 37717C Communications Performance Analyzer accepts a 576 kb/s test pattern via the protocol analyzer port, inserting the test pattern in bytes D4 - D12 of the Multiplexer Section overhead and transmitting an STM-1 optical

SDH Testing DCC Testing

signal. The HP 37717C Communications Performance Analyzer receives the STM-1 optical signal and drops the Multiplexer Section DCC, via the protocol analyzer port, to the HP 37732A which performs the BER measurement.



STATUS: UNITERNAL

EXT MTS EXT MTS STM-4 CLOCK DATA OPT REC MULTIPLE WINDOW

connected to the front panel 2M REF IN port. The format can be CLOCK or DATA.

SDH Testing DCC Testing

3. Set up the **TRANSMIT**; TEST FUNCTION display as shown opposite.

TATUS: RS DCC MS DCC			MULTI
DCC BYTE POLARITY	[NORMAL	3	
TEST FUNCTION [SDH	JE DCC INSEF E MS DCC	E 18	
SDH JITTER DUTPUT	C SDH OVERHEAD ON SETUP	3	

4. Set up the **RECEIVE**; TEST RECEIVER INPUT [SDH 3 FUNCTION display as shown opposite. STRUCT'D TEST OVERHEAD PAYLORD FUNCTION MONITOR SDH TEST FUNCTION E DCC DROP E MS DCC] DCC BYTE POLARITY [NORMAL 1 STATUS: MULTIPLE WINDOW

Start the DCC Test

1. Select TEST SELECT DATACOM on the HP 37732A.

2. Set TX Clock Source and RX Clock Source to [INTERFACE] on the HP 37732A (Clock from HP 37717C protocol port).

3. Select the required pattern and monitor logic errors and frequency to verify the integrity of the DCC.

SDH Testing Desynchroniser Stress

Desynchroniser Stress

Application

At the boundary of the SDH network the 2 Mb/s or 140 Mb/s payload is demapped from the SDH signal. Pointer adjustments in the signal may cause high levels of tributary jitter in the output payload. Excessive amounts of tributary jitter will result in errors.

The desynchronizing phase lock loop of the network element should minimize the level of tributary jitter in the payload but correct operation under stress conditions must be verified. The desynchronizing phase lock loop can be stressed by adding pointer movement sequences (defined in CCITT standard G.783) to the SDH signal such that the test virtual container moves with respect to the SDH frame.

A jitter measurement is made to verify that the desynchroniser output jitter is within the required specification.

Default (Known State) Settings

It is advisable to set the HP 37717C to a known state before setting up a measurement. This clears all previous settings and provides a clearly defined instrument state. The default settings are set by selecting **OTHER STORED SETTINGS** STORED SETTING NUMBER 0 and pressing **RECALL**

Desynchroniser Stress Test Setup Procedure

The following options must be fitted to the HP 37717C to perform this test:

- UKK [USB] or UKJ [USA]- PDH module
- A3L, A3V or A3N Jitter measurement module
- A3R [A3S]- SDH module
- 130 or 131 STM-0/1/4 Optical interface

The HP 37717C Communications Performance Analyzer transmits an STM-4 optical signal carrying 2 Mb/s payload. Pointer movement sequences are added in a controlled manner. The desynchroniser output is returned to the HP 37717C and a jitter measurement is performed on the demapped 2 Mb/s signal.

SDH Testing Desynchroniser Stress



 Connect the HP 37717C to the network equipment and set up the TRANSMIT;
 SDH display as shown opposite.
 The CLOCK SYNC selection determines the synchronization source for the TRANSMIT clock. If EXTERNAL MTS is selected a 2 Mb/s reference must be connected to the 2M REF IN port. The format can be CLOCK or DATA.

2. Set up the **TRANSMIT**; TEST FUNCTION display as shown opposite.

Pointer adjustments are made every 10 ms with an extra ADDED adjustment as defined in CCITT standard G.783.

Pointer sequences are started by selecting **STARTED**.

TRANSMITTER OUTPUT SDH STRUCT'D JIT PAYLOAD SIGNAL ESTM-4 OPTJE CLOCK EEXT MTS CLK	E SDH J TER TEST OVERHERD FUNCTION SETUP 1310 JEINTERNAL J J OFFSET E OFF J	
MRPPING ERU-4 2M OFFSET CHRINEL STM-1 Eij Tu Prylord [1] Pritern [2^15-1 Pr]	і НОІЗВАДИЛИ] [TU-12] [RSYNC 2Mb/s] [C 0 рерт] TUB3 [TUB2 TU [L] UNERATED] IS3 [INVERT] ITU	
STATUS: F/G B/G MAPPING MAPPING		MULTIPLE WINDOW



SDH Testing Desynchroniser Stress

3. Set up the **RECEIVE**; **PDH** JITTER display as shown opposite.

SHORT TERM PERIOD need only be set if it is intended to view Short Term results

RECEIVER INPUT MAIN STRUCT'D UITTER SETTINGS SETTINGS	[PDH	3
SIGNAL FREQUENCY	2 Mb/s	
RECEIVER RANGE HIT THRESHOLD FILTER ADDITIONAL RMS FILTER	[1.6 UI [0.50 UI [DFF [DFF	1 1 1 1
WANDER WANDER REFERENCE WANDER REF. FORMAT CONNECT 2Mb/s SOURCE to J1	[ON [75Ω UNBAL [HDB3 DATA TTER RX MODUL]] E
STATUS:		MULTIPLE Window

4. Set up the **RESULTS** display as shown opposite. .

RESULTS ETIMING SHORT TERM PERI TEST TIMING	CONTROL] OD [1 SECOND [MANUAL]		1	
GRAPH STORAGE	i off C Internal]	
STATUS:				
OFF 1 SE RESOL	C 1 MIN 'N RESOL'N	15 MIN RESOL'N	1 HR RESOL'N	MULTIPLE

Start the Desynchroniser Stress Test

1. Press **RUN/STOP** to start the Jitter measurement.

Jitter Hits or any other result can also be viewed without affecting the measurement

RESULTS [JITTER HITS ANPLI TUDE	JE CUMULATIVE	3	
+VE PEAK -VE PEAK PEAK-PEAK FILTERS ELAPSED TIME	OFF	U I U I U I	
STATUS:			

Frame Synchronization

Application

A network element should maintain synchronization even in the presence of some frame errors. If the number of frame errors exceeds the specified threshold for 3 ms, the network element will lose frame synchronization causing a new search for frame alignment to begin.

The frame synchronization process of the network element can be stressed by injecting frame errors, into the A1 and A2 framing bytes of the Regenerator Section overhead. As the frame error injection rate is increased to the frame synchronization threshold, the network element should indicate Out Of Frame (OOF) and Loss Of Frame (LOF) conditions. As the frame error injection rate is decreased again, the network element should regain frame synchronization.

Default (Known State) Settings

It is advisable to set the HP 37717C to a known state before setting up a measurement. This clears all previous settings and provides a clearly defined instrument state. The default settings are set by selecting **OTHER STORED SETTINGS** STORED SETTING NUMBER 0 and pressing **RECALL**

Frame Synchronization Test Setup Procedure

Frame Error Add Test Function In this setup the HP 37717C Communications Performance Analyzer is used to insert frame errors in the A1 and A2, framing bytes of the Regenerator section overhead of an STM-1 optical signal. The STM-1 optical signal is transmitted to the network equipment. The network equipment OOF and LOF alarms are monitored as the frame error add rate is increased and decreased.

Sequence Generation Test Function

In this setup procedure the HP 37717C Communications Performance Analyzer generates a sequence of errored framing bytes to test the OOF and LOF alarm threshold criteria. The upstream STM-1 optical signal is monitored for occurrences of Multiplexer Section FERF. The downstream STM-1 optical signal can be monitored for AIS.





3. Set up the **RESULTS** display as shown opposite

SHORT TERM PERIOD need only be set if it is intended to view Short Term results.

4..ALARM SECONDS are displayed but any of the other results can be selected from the softkey menu without affecting the measurement

The MS-RDI indicator on the front panel in conjunction with **SHOW HISTORY** will also give an indication that the MS-RDI alarm has occurred.

5. Set up the **TRANSMIT**; TEST FUNCTION display as shown opposite.





Start the Frame Synchronization Test (Frame Error Add)

1. Check that the Loss Of Frame (LOF) alarm indicator on the network element remains unlit and no occurrences of MS-RDI are recorded.

2. Increase the Frame Error Add Rate to 2 IN 4 and check that the Loss Of Frame (LOF) alarm indicator on the network element remains unlit and no occurrences of MS-RDI are recorded.

3. Increase the Frame Error Add Rate to 3 IN 4 and check that the Loss Of Frame (LOF) alarm indicator on the network element remains unlit and no occurrences of MS-RDI are recorded.

4. Increase the Frame Error Add Rate to 4 IN 4 and check that the OOF and LOF alarm indicators on the network equipment are lit and occurrences of MS-RDI are recorded.

5. Decrease the Frame Error Add Rate to 3 IN 4 and check that the OOF and LOF alarm indicators on the network equipment remain lit and occurrences of MS-RDI are still being recorded.

6. Decrease the Frame Error Add Rate to 2 IN 4 and check that the OOF and LOF alarm indicators on the network equipment go off, and no further occurrences of MS-RDI are recorded.

Sequence Generation Test Function

1. Connect the HP 37717C to the network	FUNCTION [SETTINGS CONTROL]
equipment and set up the OTHER	
SETTINGS CONTROL display as shown	RECEIVER COUPLED TO TRANSMITTER
opposite.	

STATUS: INDEP-ENDENT

COUPLED

2. Set up the **TRANSMIT**; **SDH** display as shown opposite.

The CLOCK SYNC selection determines the synchronization source for the **TRANSMIT** clock. If **EXTERNAL MTS** is selected a 2 Mb/s reference must be connected to the front panel 2M REF IN port. The format can be CLOCK or DATA.

1	STATUS:	
	PAYLORD TYPE [UNFRAMED PATTERN [2^23-1 PRBS] [INVERT] ITU	1
e	MAPPING AU-4 E FOREGROUND UC-4 E UC-4 140M OFFSET E 0 PPM	1 1 1
	SIGNAL [STM-1 OPT][1310][INTERNAL CLOCK [INTERNAL] OFFSET [OFF	.]
5	TRANSMITTER OUTPUT E SDH) IEAD IP

3. Set up the **RESULTS** display as shown opposite

SHORT TERM PERIOD need only be set if it is intended to view Short Term results.

GRAPH STORAGE	i off C Internal	3	

4..ALARM SECONDS are displayed but any of the other results can be selected from the softkey menu without affecting the measurement.

RESULTS [SDH	<u>i</u> c alarm seconds		
POWER LOSS LOS OF MS-FIS MS-FIS AU-RIS ELRPSED TIME	K1/K2 CHANGE MS-RD1 H-RDM H-RDM TU-LDP TU-LDP TU-RIS LP-RDI		
STATUS: Alarm Freq- Seconds Uency	POINTER POINTER Values graph	MORE	MULTIPLE WINDOW

Start the Frame Synchronization Test (Sequence Test)

1. Set up the **TRANSMIT** TEST FUNCTION display as shown opposite.

2. Press **STARTED** on the **TRANSMIT** TEST FUNCTION display to start the sequence. As a result of this sequence one OOF alarm second and one LOF alarm second should occur every two seconds.

3. Check that the network element OOF and LOF alarm indicators cycle ON and OFF and that an occurrence of MS-RDI is recorded every two seconds.

3. Press **STOPPED** to stop the sequence and set up the **TRANSMIT** TEST FUNCTIONdisplay as shown opposite.

4. Press **STARTED** on the **TRANSMIT** TEST FUNCTION display to start the sequence. As a result of this sequence one OOF alarm second should occur every two seconds but LOF should not occur.

5. Check that the network element OOF alarm indicator cycles ON and OFF. The LOF alarm should not occur and no occurrences of MS-RDI should be recorded.





SDH Testing SDH Jitter Transfer

SDH Jitter Transfer

Digital transmission systems use Regenerators to transport the signal over long distances. These Regenerators are cascaded together and it is important that each regenerator adds minimal amounts of jitter to the signal.

It is necessary during installation and maintenance to measure the degree to which jitter present at the input is amplified or attenuated by the network elements (Jitter Gain/Transfer).

The jitter transfer measurement entails measuring the input and output jitter at selected jitter frequencies within the jitter bandwidth. The jitter gain is calculated : Jitter Gain (dB) = $20 \text{ Log } \{\text{Jitter out } \setminus \text{over Jitter in} \}$

When the network equipment meets CCITT specification G.823 it should be possible to connect network elements without incurring bit errors.



Default (Known State) Settings

It can be advisable to set the HP 37717C to a known state prior to setting up to make a measurement. This clears all previous settings and provides a clearly defined instrument state. The default settings are set by selecting **OTHER STORED SETTINGS** STORED SETTING NUMBER 0 and pressing **RECALL**

Test Setup Procedure (Jitter Transfer Test)

The following Options must be fitted to the HP 37717C to perform this test :

• A3K - Jitter and Wander Generation

SDH Testing SDH Jitter Transfer

- A3V or A3N- SDH Jitter Measurement
- A3R [A3S] SDH Module

This setup procedure is based on 155.52 Mb/s (STM-1), 140 Mb/s payload, PRBS test data with jitter. The Jitter frequency is varied within the jitter bandwidth and the received jitter is measured to allow calculation of the jitter gain.

 Set up the OTHER SETTINGS CONTROL display as shown opposite. Any SDH settings change made on the TRANSMIT or RECEIVE displays will automatically occur on the other. 	FUNCTION E SETTINGS CONTROL 3 TRANSMITTER AND RECEIVER (COULDED) RECEIVER COUPLED TO TRANSMITTER	
2. Connect the HP 37717C to the line equipment, select TRANSMIT ; SDH and set up the display as shown opposite.	STRTUS: ENDER: EDUPLER SOL STRUCTO JITTER TEST DUERHEND SOL STRUCTO JITTER TEST DUERHEND SIBHRL (STR-1) JOFFSET [DFFSTUP] SIBHRL (STR-1) JOFFSET [DFFSTUP] SIBHRL (STR-1) JOFFSET [DFFSTUP] ILCOK [INTERNAL] OFFSET [DFFSTUP] NAPPING RU-4 [FOREGROUND] 140M OFFSET [DC-4 Mb/s] PAYLORD TYPE [2023-1 PRBS] [INVERT] ITU]	MULTIPLE
	STATUS:	MULTIPLE WINDOW

3. Select **TRANSMIT**; JITTER and set up the display as shown opposite.

Select the required Jitter MODULATING FREQUENCY and AMPLITUDE.

TRANSMITTER OUTPUT SDH STRUCT'D	C T FUN	SDH EST OVERHI CTION SETU	and a second sec
JITTER / WANDER JITTER SIGNAL FREQUENCY MODULATION SOURCE JITTER MASK		JITTER DN STM-1 INTERNAL DFF]
CLOCK SYNC		INTERNAL	
RANGE MODULATION FREQUENCY AMPLITUDE		1.0 UI 1000 Hz 1.00 UI]
STATUS:			MULTIPLE WINDOW
SDH Testing SDH Jitter Transfer

4. Setup the **RECEIVE**; **SDH JITTER** display as shown opposite.

If Jitter filtering is required select from the softkey menu.

RECEIVER INPUT	[SDH JITTER	
SIGNAL	[STM-1	3
RECEIVER RANGE HIT THRESHOLD FILTER	[16 UI [0.5 UI [DFF]
LEVEL	[TERMINATE	3
CTRTUE.		
PDH SDH	ATM SDH JITTER	MULTIPL WINDOW

Run the Test (Jitter Transfer)

1. Select **RESULTS** and set up the display as shown opposite.

SHORT TERM PERIOD need only be set if it is intended to view Short Term results.

2.Press **RUN/STOP** to start the measurement.

3. Record the Jitter Amplitude result from the **RESULTS** display.

4. Select each jitter Modulating Frequency and Amplitude in turn on the **TRANSMIT** display, press **RUN/STOP** twice and record the Jitter Amplitude result from the RESULTS display.

5. Calculate the Jitter gain for each frequency selected.

Jitter Gain (dB) = 20 Log {Jitter out / Jitter in}. Where Jitter In is the AMPLITUDE selected on the **TRANSMIT** display.

RESULTS ETIMING	CONTROL 3			
SHORT TERM PERIC TEST TIMING	ID [1 SECOND [MANUAL]		נ	
GRAPH STORAGE	C OFF			
STATUS: OFF 1 SEC		15 MIN		
RESUL	K MESULAN	NESUL'N	NEOUL N	HINUU

RESULTS I JITTER	E SHORT TERM	
+VE PEAK	UI	
-VE PEAK	UI	
РЕАК-РЕАК	UI	
FILTERS	OFF	
ELAPSED TIME		
STRUIS:		
TROUBLE TIMING Scan Control	JITTER	MULTIPLE WINDOW

MSP Stimulus/Response

Application

Multiplexer Section Protection (MSP) is an optional feature for SDH Multiplexer Section Terminating Equipment (MSTE). For those MSTE's, in which it is provided, the MSP system is standardized to ensure the interworking of MSP between MSTE's from different suppliers.

Standard messages, carried in the K1 and K2 bytes of the SDH signal transport overhead, indicate the state of the MSP.

Switching to the protection line occurs when one of the following conditions exists for a specified length of time :

- Loss Of Signal (LOS)
- Loss Of Frame (LOF)
- Signal Fail Bit Error Ratio > 1 X 10⁻³
- Signal Degrade Bit Error Ratio programmable
- MS-AIS

The Signal Degrade Bit Error Ratio threshold is normally programmable in the range 1 X 10^{-5} to 1 X 10^{-9} .

The HP 37717C Communications Performance Analyzer can be used to test Multiplexer Section Protection switching by :

Generating the switching conditions listed above.

Transmitting and monitoring the K1 K2 messages.

MSP Stimulus/Response 1+1 Architecture Test Setup Procedure

In this setup the HP 37717C PDH/SDH test set, inserted in the working line, generates B2 BIP errors in sufficient quantity to violate the Signal Degrade threshold of the Multiplexer Section Protection. The network equipment Service Terminal indicates that switching to the standby line has occurred. The activity on the K1 K2 bytes can be monitored on the TRANSMIT TEST FUNCTION MSP Messages display.



1. Set up the **TRANSMIT**; **SDH** display as shown opposite.

The CLOCK SYNC selection determines the synchronization source for the TRANSMIT clock. If EXTERNAL MTS is selected a 2 Mb/s reference must be connected to the front panel 2M REF IN port. The format can be CLOCK or DATA.

TRANSMITTER OUTPUT SDH STRUCT'D JITT PRUCAD SIGNAL [STM-1 OPT]E CLOCK LINTERNAL	E SDH ER TEST OVERI FUNCTION SETI 1310 JEINTERNAL DEFSET FORF] IEAD IP
MRPPING RU-4 140M DFFSET	E FOREGROUND E VC-4 E 140 Mb/s E 0 ppm	2
PAYLOAD TYPE Pattern [2^23-1 prb	[UNFRAMED S] [INVERT] ITU	1
STATUS:		MULTIPLE

2. Set up the **TRANSMIT**; TEST FUNCTION display as shown opposite.

1530 B2 BIP errors in 1 second corresponds to a BER of 1 in 10^{-5} . The Service terminal should indicate switching to standby within 1 second.

		-
TRANSMITTER DUTPUT	[SDH]	
SDH STRUCT'D JITTER PRYLORD	TEST OVERHEAD FUNCTION SETUP	
TEST FUNCTION [SDH	I ERR & ALARM)	
ERROR ADD TYPE RATE [1530] ERROR	[MS B2 BIP] [MSP THRESHLD] S IN [1 s]	
ALARM TYPE	C OFF 3	
STATUS: Errors adjust seque & Alarms pointer	NCE MSP MORE MULTIPL MESSAGES	Ξ

MSP Stimulus/Response 1:N Architecture

The HP 37717C Communications Performance Analyzer **TRANSMIT**; TEST FUNCTION ; **MSP MESSAGES** can be used to transmit and monitor the K1 K2 messages.

The MSP Messages are transmitted when **DOWNLOAD** is pressed.

Two displays of K1 and K2 are provided :

1. Current **TX** - Values of K1 and K2 bytes which are currentlybeing transmitted.

2. Current **RX** - Values of K1 and K2 bytes which are currentlybeing received.

TRANSMITTER OUTPUT SDH STRUCT'D JITTER PAYLOAD	C SDH 3 TEST OVERHEA FUNCTION SETUP	D
TEST FUNCTION [SDH NEM TX TOPOL K1 BITS 1->4 [1000:MRNU BITS 5->8 [0011:WORK K2 BITS 1->4 [0010] BRI BIT 5 [1: 1:N BITS 6->8 [000: RES	JEMSP MESSAGESJ DGY ELINEARJ AL SWITCH J ING CHANNEL 3 J DGED CHANNEL NO. ARCHITECTURE J ERUED J	
CURRENT TX K1 K2	CURRENT RX K1 K2	
TRANSMIT NEW K1/K2		
STATUS: SELECT DOWN Lord		MULTIPLE WINDOW

K1 Bits 1 ->4 Selects the MSP message to be transmitted.

Table 1 K1 Bits 1 - >4

Selection	Message	Selection	Message
0000	NO REQUEST	1000	MANUAL SWITCH
0001	DO NOT REVERT	1001	NOT USED
0010	REVERSE REQUEST	1010	SD - Low Priority
0011	NOT USED	1011	SD - High Priority

Table 1 K1 Bits 1 - >4

Selection	Message	Selection	Message
0100	EXERCISE	1100	SF - Low Priority
0101	NOT USED	1101	SF - High Priority
0110	WAIT TO RESTORE	1110	FORCED SWITCH
0111	NOT USED	1111	LOCKOUT OF PROT

SD - High Priority and SF - High Priority are only available when K2 bit 5 is set to 1 (1 : N architecture).

K1 Bits 5 ->8 Selects the channel used by the MSP Messages.

Table 2

K1 Bits 5 - >8

Selection	Message	Selection	Message
0000	NULL CHANNEL	1000	WORKING CHANNEL #8
0001	WORKING CHANNEL #1	1001	WORKING CHANNEL #9
0010	WORKING CHANNEL #2	1010	WORKING CHANNEL #10
0011	WORKING CHANNEL #3	1011	WORKING CHANNEL #11
0100	WORKING CHANNEL #4	1100	WORKING CHANNEL #12
0101	WORKING CHANNEL #5	1101	WORKING CHANNEL #13
0110	WORKING CHANNEL #6	1110	WORKING CHANNEL #14
0111	WORKING CHANNEL #7	1111	EXTRA TRAFFIC CHANNEL

WORKING CHANNEL #2 through WORKING CHANNEL #14 and EXTRA TRAFFIC CHANNEL are only available when K2 Bit 5 is set to 1 : N architecture. If K1 bits 1 >4 are set to 1111 LOCKOUT OF PROT then K1 bits 5 ->8 are fixed at 0000 NULL CHANNEL.

K2 bits 1 - >4	Selects the bridged channel used by the MSP Messages. Can be set in the range 0000 to 1111.
K2 bit 5	Determines the automatic protection switch architecture. 0 $(1 + 1 \text{ architecture}), 1 (1 : N \text{ architecture})$

SDH Testing Optical Clock Recovery Stress

Optical Clock Recovery Stress

Application

Ideally the clock recovery circuits in the network equipment optical interfaces should recover a clock even in the presence of long strings of 0's.

The optical clock recovery performance of the network equipment can be measured by increasing the length of a zero substitution block until errors occur.

Default (Known State) Settings

It is advisable to set the HP 37717C to a known state before setting up a measurement. This clears all previous settings and provides a clearly defined instrument state. The default settings are set by selecting **OTHER STORED SETTINGS** STORED SETTING NUMBER 0 and pressing **RECALL**

Optical Clock Recovery Stress Test Setup Procedure

In this setup procedure the HP 37717C Communications Performance Analyzer transmits an STM-1 optical signal with zero's substituted into the payload data pattern. The length of the block of zero's is increased until the network equipment alarms are triggered.



SDH Testing Optical Clock Recovery Stress

1. Connect the HP 37717C to the network equipment and set up the **TRANSMIT**; **SDH** display as shown opposite.

The CLOCK SYNC selection determines the synchronization source for the **TRANSMIT** clock. If **EXTERNAL MTS** is selected a 2 Mb/s reference must be connected to the front panel 2M REF IN port. The format can be CLOCK or DATA.

TRANSMITTER OUTP SDH STRUCT'D PAYLOAD SIGNAL ESTM-1 O CLOCK EEXT MTS C	UT JITTER FL IPTJE 1310 LK J OFFSE	E SDH TEST OVERHE JNCTION SETUP JE INTERNAL T E OFF	1 RD 1
MAPPING A 140M OFFSET	IU-4 [[[FOREGROUND VC-4 140 Mb/s 0 ppm]]]
PRYLORD TYPE PRTTERN [2^15-	1 PRBS] [IN	UNFRAMED IVERT] ITU	1
STATUS:			MULTIPLE Window

2. Set up the **TRANSMIT**; TEST FUNCTION display as shown opposite G.958 Test Pattern consists of consecutive blocks of four types of data : All 1's PRBS All 0's a data block consisting of the first row of section overhead bytes.

SDH STRUCT'D PRYLORD	JITTER	FUN	EST C	VERHER	ID	
TEST FUNCTION [SDH	30	STRESS	TEST	1	
STRESSING PATTER BLOCK LENGTH	RN	Ē	ALL ZE 2]	ROS BYTES	1	

Start the Optical Clock Recovery Stress Test

Increase the Block Length until the network equipment alarms are triggered.

Payload Mapping/Demapping

Application

The mapping and demapping of a 2 Mb/s or 140 Mb/s payload into/from the appropriate SDH containers should take place without introducing errors.

The mapping process is tested by inserting a test pattern in the 2 Mb/s or 140 Mb/s payload at the low-rate side of the terminal multiplexer. On the high-rate side of the terminal multiplexer, the payload is demapped from the SDH signal by the HP 37717C Communications Performance Analyzer.

The demapping process is tested by transmitting a SDH signal to the high-rate side of the multiplexer. On the low-rate side of the multiplexer the payload is received by the HP 37717C Communications Performance Analyzer.

A Bit error rate (BER) test is performed on the recovered payload test pattern to determine whether errors have been introduced by the mapping process.

Default (Known State) Settings

It is advisable to set the HP 37717C to a known state before setting up a measurement. This clears all previous settings and provides a clearly defined instrument state. The default settings are set by selecting **OTHER STORED SETTINGS** STORED SETTING NUMBER 0 and pressing **RECALL**

Payload Mapping/Demapping Test Setup Procedure

The following Options must be fitted to the HP 37717C to perform this test :

- UKJ or UKK PDH Module
- A3R [A3S] SDH Module
- UH1, 130 or 131 STM-1/STM-4 Optical Interface

For mapping a 140 Mb/s payload, containing a test pattern, is transmitted into the low-rate side of the terminal multiplexer. The 140 Mb/s payload is demapped from the STM-4 Optical signal at the high-rate side of the terminal multiplexer.

For demapping an STM-4 Optical signal is transmitted into the high-rate side of the Add Drop multiplexer. The 140 Mb/s signal, on the low-rate side of the Add Drop multiplexer, is received by the HP 37717C Communications Performance Analyzer.

A BER measurement is performed on the demapped 140 Mb/s payload test pattern.

A SINGLE test period of 24 HOURS is used and the internal printer is enabled to record results and alarms.

The HP 37717C Communications Performance Analyzer GRAPHICS function is enabled. The graphical results can be viewed on the GRAPH display



Payload Mapping

Payload Demapping



1. Connect the HP 37717C to the network equipment and set up the **OTHER SETTINGS CONTROL** display as shown opposite.

FUNCTION	[SETTIN	IGS CONTROL]	_
TRANSMITTER	AND RECEIVER	[INDEPENDENT]	
STRTUC.			
INDEP- C ENDENT	COUPLED		MULTIPLE WINDOW

2. For Mapping set up the **TRANSMIT** display as shown opposite.

TRANSMITTER OUTPUT MAIN STRUCT'D JI SETTINGS SETTINGS	TTER TEST FUNCTION	
SIGNAL	[140 Mb/s]	
CLOCK SYNC TERMINATION LINE CODE FREQUENCY OFFSET	INTERNAL 75Ω UNBAL CMI E OFF 3	
PAYLOAD TYPE PATTERN PRBS POLARITY	[UNFRAMED] [2^23-1 PRBS] [INV] ITU	
STATUS: PDH SDH	АТМ	MULTIPLE WINDOW

2a. For Demapping set up the TRANSMIT display as shown opposite.	TRANSMITTER OUTPUT C SDH J SDH STRUCT'0 JITTER FUEST OUERHEAD SIGNAL CSTM-4 OPTIC 1310 JITTERNAL SLORAL CSTM-4 OPTIC 1310 JITTERNAL MAPPING C HU-4 [FOREDROUND] JICO JICO 1400 OFFSET [60 Hb/s J JICO CHRNHEL PAYLORD TW-1 [60 PPH J OPFN J PAYLORD TW-1 [60 PPH J PHONE J PAYLORD TYPE [60 PPH J D PHONE J
	STATUS: 2 3 4 MULTIPUE MINDON

3. For Mapping set up the **RECEIVE** display as shown opposite.

RECEIVER INPUT E SDH SDH STRUCT'D TEST OVERHEAD PAYLORD FUNCTION MONITOR	3
SIGNAL [STM-1 OPT]	
MAPPING AU-4 [VC-4]E 140 Mb/s	1
PAYLOAD TYPE C UNFRAMED PATTERN C 2^23-1 PRBSJC INVERTJ ITU	1
STATUS:	MULTIPLE WINDOW

3a. For Demapping set up the **RECEIVE** display as shown opposite.

RECEIVER INPUT	C	PDH	1	
SIGNAL	C	140 Mb/s	3	
TERMINATION		75Ω UNBAL		
LEVEL	C	TERMINATE	1	
PAYLORD TYPE PATTERN PRBS POLARITY		UNFRAMED 2^23-1 PRB INU] ITU	s]	
STATUS:				MULTIPLE WINDOW

4. Set up the **OTHER** display, **LOGGING** function, as shown opposite.

All results are logged to the selected logging device at 1 hour intervals. Any alarms which occur during the test period will be logged To the selected logging device.

r			
FUNCTION	E LOGGING	1	
LOGGING SETUP	C CO	NTROL]	
LOGGING LOGGING PERIOD	E ON E 1	HOUR]	
RESULTS LOGGED WHEN CONTENT	[SE	LECTED] Ridod Ecxor & Anal]	
LOG ERROR SECONDS LOG AT END OF TES		F] L RESULTS	
LOG ON DEMAND	RE	SULTS	
ALWAYS PERIOD EC > 0			MULTIPLE WINDOW

Start the Payload Mapping/Demapping Test

1. Set up the **RESULTS** display as shown opposite. If you do not require stored graphics results select STORAGE [OFF].

SHORT TERM PERIOD need only be set if it is intended to view Short Term results.

2. Press **RUN/STOP** to start the measurement.

RESULTS [TIMING SHORT TERM PERIO	CONTROL] D [1 SECOND	24 HOURS	ļ	
GRAPH STORAGE	C 15 NIN RESU C INTERNAL	JL'N		
STATUS: OFF 1 SEC RESOL '	1 MIN RESOL'N	15 MIN RESOL'N	1 HR RESOL'N	MULTIPLE WINDOW

The measurement results and alarms are available on the RESULTS display during the test period.

The graphical measurement results and alarms are stored in non volatile memory for viewing later on the **GRAPH** display.

The test can be halted at any time by pressing **RUN/STOP**.

RESULTS	L PDH PAYLOAD IE ERROR ANALYSIS] G.826 N.2100 M.2110 BIT	
EC ES EFS UNRU DEG MIN CODE ES ELRPSED	RND ES 2 2 2 2 2 2 2 2 2 2	
STATUS:		MULTIPLE WINDOW

At the End of the Test (Payload Mapping/Demapping)

- The Date and Time the test started and the instrument setup are logged to the selected logging device.
- All results are logged to the selected logging device at 1 hour intervals.
- Any alarms which occur during the test period will be logged to the selected logging device.
- At the end of the test period a complete set of cumulative results are logged to the selected logging device.
- A graphical record of the results during the test period can be viewed on the GRAPH display. If a printer option is fitted the graph results can be logged to a printer, at a later date.
- Results and Alarm summaries can be viewed on the **GRAPH** display.

The total graphics store capacity is normally 20,000 events. An event is the occurrence of an error or an alarm.

The resolution, determined by the selection made under STORAGE on the **RESULTS** display, affects the ZOOM capability when viewing the bar graphs. If 1 SECOND is selected all resolutions are available under ZOOM. If 1 MIN is selected only 1 MIN/BAR, 15 MINS/BAR and 60 MINS/BAR are available. If 15 MINS is selected only 15 MINS/BAR and 60 MINS/BAR are available. If 1 HOUR is selected only 60 MINS/BAR is available.

Up to 10 sets of graphical results can be stored. If an attempt is made to store more than 10 sets of results, then a first in first out policy is operated and the oldest set of results will be lost. If graphics are enabled and a test is run which exceeds the remaining storage capacity, then some previously stored graphical results will be lost.

To prevent accidental overwriting of previously stored results the graphics capability should be disabled, when graphical results are not required, by selecting STORAGE [OFF] on the **[RESULTS]** display.

Performance Monitor Stimulus / Response

Application

Performance monitors built into the SDH network equipment count BIP errors, and communicate the results to the network controller via the Data Communication Channel (DCC). Performance monitors in Path Terminating Equipment (PTE) also communicate with the upstream equipment.

If the performance monitors are not operating correctly, degradations in network performance will pass unnoticed and may result in a failure condition.

The performance monitors can be tested by the Communications Performance Analyzer transmitting BIP errors in the appropriate byte of the overhead and monitoring upstream for the correct response :

Regenerator Section (RS) - B1 Byte of regenerator section overhead

Multiplexer Section (MS) - B2 Bytes of multiplexer section overhead

PATH B3 - B3 Byte of path overhead

Default (Known State) Settings

It is advisable to set the HP 37717C to a known state before setting up a measurement. This clears all previous settings and provides a clearly defined instrument state. The default settings are set by selecting **OTHER STORED SETTINGS** STORED SETTING NUMBER 0 and pressing **RECALL**

Performance Monitor Stimulus/Response Test Setup Procedure

The following Options must be fitted to the HP 37717C to perform this test :

- A3R SDH Module
- UH1,130 or 131 STM-1/STM-4 Optical Interface

In this setup the HP 37717C Communications Performance Analyzer inserts "PATH" B3 BIP errors in byte B3 of the path overhead of the SDH signal. The upstream signal is monitored to provide a measure of the FEBE (Far End Block Error) count.

SDH Testing Performance Monitor Stimulus / Response



1. Connect the HP 37717C to the network equipment and set up the **OTHER**; **SETTINGS CONTROL** display as shown opposite.

FUNCTION	E SETTINGS CONTR	ROL]
TRANSMITTER A	ND RECEIVER	LED]
RECEIVER	COUPLED TO TRANSMITTE	2R
TATUS:	IPI FN	MILTI

2. Set up the **TRANSMIT**; **SDH** display as shown opposite.

The CLOCK SYNC selection determines the synchronization source for the **TRANSMIT** clock.

TRANSMITTER DUTPUT E SDH SDH STRUCT'D JITTER TEST DVERH PRYLOAD FUNCTION SETU] IEAD IP
SIGNAL [STM-1 OPT][1310][INTERNAL CLOCK [INTERNAL] OFFSET [OFF	3
MAPPING AU-4 EUC-4 EUC-4 140M OFFSET E 0 PPM	1]]
PAYLORD TYPE E UNFRAMED PATTERN [2^23-1 PRBS][INVERT] ITU	1
STATUS: F/G B/G MAPPING MAPPING	MULTIPLE WINDOW

SDH Testing Performance Monitor Stimulus / Response

3. Set up the **RESULTS** display as shown opposite.

SHORT TERM PERIOD need only be set if it is intended to view Short Term results

RESULTS [TIMING SHORT TERM PERIC	CONTROL] ID [1 SECOND]		
TEST TIMING	[MANUAL]				
BRAFA STURAGE	C INTERNAL		5		
STATUS:					
OFF 1 SEC RESOL	1 MIN RESOL'N	15 MIN RESOL'N	1 HR RESOL'N	MULTIPLE	

HP-REI ERROR RESULTS are displayed but any of the other results can be selected from the softkey menu without affecting the measurement.

RESULTS (SDH) CUMULATIVE) PATH B3 PATH PATH BIP FEBE IEC MORE	
FEBE EC FEBE ER	
ELAPSED TIME	
STATUS:	

4. Set up the **TRANSMIT**; TEST FUNCTION display as shown opposite.

The ERROR RATE required can be selected from the softkey menu.

TRANSMITTER OUTPUT SDH STRUCT'D JITTER PRYLOAD	E SDH TEST OVER FUNCTION SET] HEAD UP
TEST FUNCTION [SDH	JE ERR & ALA	RM]
ERROR ADD TYPE RATE	[B3 BIP [1E-4]
ALARM TYPE	[OFF	1
STATUS:		MULTIPLE Window

SDH Testing Performance Monitor Stimulus / Response

Start the Performance Monitor Stimulus/Response Test

1. Press **RUN/STOP** on the HP 37717C Communications Performance Analyzer.

2. Check that the HP-REI error rate is the same as the generated B3 BIP rate.

All the measurement results are available, throughout the test, on the $\fboxtimestic RESULTS$ display .

At the end of the test :

• the cumulative measurement results are available on the **RESULTS** display.

Selective Jitter Transfer Measurement

The problem with many SDH jitter analyzers is the fact that their receivers are wideband receivers and are not able to measure within a sufficiently narrow bandwidth. The reason is that these instruments are designed to measure peak to peak jitter in the transmission network for troubleshooting purposes and are not designed to make selective jitter measurements. The jitter analyzer just measures the peak-peak value of the incoming jitter over a wide frequency range. The problem occurs when testing the jitter transfer of real network equipment i.e. SDH regenerators.

The regenerator produces intrinsic jitter and this disturbs the measurement as the jitter receiver cannot determine whether it is measuring the jitter produced by the jitter analyzers transmitter or the intrinsic jitter which is generated, at a different frequency, by the regenerator. The problem is greatest at the higher jitter modulating frequencies when the amount of jitter generated, as per ITU-T G.958, is much smaller. The measurement is corrupted by the higher amplitude intrinsic jitter generated by the regenerator at lower frequencies and incorrectly measured by the analyzer.

The accurate method for measuring jitter transfer requires a selective measurement. One such method is to use a network analyzer in conjunction with the HP 37717C. The network analyzer provides the capability to measure jitter selectively and has increased sensitivity.

Default (Known State) Settings

It can be advisable to set the HP 37717C to a known state prior to setting up to make a measurement. This clears all previous settings and provides a clearly defined instrument state. The default settings are set by selecting **OTHER STORED SETTINGS** STORED SETTING NUMBER 0 and pressing **RECALL**

Test Setup Procedure (Jitter Transfer Test)

The following Options must be fitted to the HP 37717C to perform this test:

- A3K Jitter Generation
- A3L or A3V or A3N SDH Jitter Measurement
- A3R [A3S] SDH Module
- UH1, 130 or 131 STM-1/4 Optical interface

SDH Testing Selective Jitter Transfer Measurement

This setup procedure is based on 155.52 Mb/s (STM-1), 140 Mb/s payload, PRBS test data with jitter. The jitter modulation is provided by the network analyzer. The HP 37717C demodulated jitter output is returned to the network analyzer for measurement. Before connecting to the regenerator to be tested the HP 37717C is looped back to back and the network analyzer is programmed to sweep over the required frequency range at the required amplitude. This provides a reference trace and removes the inaccuracies of the of the test configuration (inaccuracies of the HP 37717C and the Network Analyzer). The HP 37717C is connected to the regenerator and the network analyzer sweep is repeated. The difference between the two traces is the jitter transfer result.



Selective Jitter Transfer Test

1. Set up the OTHER SETTINGS CONTROL display as shown opposite.

Any SDH settings change made on the **TRANSMIT** or **RECEIVE** displays will automatically occur on the other.

FUNCTION	E SETTIN	GS CONTROL	1	
IRHNSMITTER H	ND RELEIVER	L LUUPLED		
RECEIVER	COUPLED TO TR	RNSMITTER		
STATUS:				
INDEP- COL	JPLED			MULTIPLE

SDH Testing Selective Jitter Transfer Measurement

2. Connect the HP 37717C to the network analyzer as shown. Connect STM-1/STM-4 IN to STM-1/STM-4 OUT. Select TRANSMIT SDH SDH and set up the

display as shown opposite.

TRANSMITTER DUTPUT E SDH	
SIGNAL [STM-4 OPT][1310][INTERNAL CLOCK [EXT MTS CLK] OFFSET [OFF	3
MAPPING C E DBEGROUND 140M DFFSET L 140 Mb/s CHRINEL STM-1 D PPH CHRINEL E 13 L PAYLORD TYPE L UNFRAMED PATTERN C2*23-1 PRBSJ CINVERTJ ITU	1
STATUS:	MULTIPLE Window

3. Select TRANSMIT SDH JITTER

and set up the display as shown opposite.

TERNSMITTER OUTPUT SDH JITTER TEST JITTER / WRNDER SIGNAL FREQUENCY MODULATION SOURCE RRNDE LOCK SYNC CONNECT 2MH2 SOURCE TO	SDH OUERHERD DN SETUP I STUP U TTER U TTM-4 C EXTERNAL C EXTERNAL EXTERNAL EXTERNAL SDH HODULE]] 	
STATUS: 2 UI 10 UI			MULTIPLE WINDOW

4. Setup the **RECEIVE SDH JITTER** display as shown opposite.

If Jitter filtering is required select from the softkey menu.

RECEIVER INPUT	[SDH JITTER]	
SIGNAL	[STM-4 OPT]	-
RECEIVER RANGE HIT THRESHOLD FILTER LEVEL	[1.6 UI] [100 UI] [H00 UI] [TERMINATE]	
STATUS: SDH SDH JITTER		MULTIPLE WINDOW

SDH Testing Selective Jitter Transfer Measurement

5. Select **RESULTS** and set up the display as shown opposite.

Press **RUN/STOP** to start the measurement.

6. Adjust the network analyzer output level until the **RESULTS** display records the required peak-peak jitter value.

7. Press **RUN/STOP** to stop the measurement.

RESULTS [JITTER HITS RMPLI TUDE	JE CUMULATIVE	3	
+VE PEAK -VE PEAK PEAK-PEAK FILTERS ELAPSED TIME	0.01 0.01 0.01 HP 1	U I U I U I	
STATUS:			MULTIPL WINDOW

8. Start the network analyzer sweep and store the resultant "reference trace"

9. Connect the HP 37717C to the regenerator as shown (loopback removed) and repeat the network analyzer sweep.

The difference between the two traces is the Jitter Transfer result.

Automatic Alarm and BIP Error Monitoring

Application

Problems in the network at all levels in the hierarchy can be detected by the occurrence of alarms or BIP errors in each tributary of SDH systems. Since an STM-4 fibre contains up to 252 TU-12 tributaries, checking each tributary individually is time consuming and laborious.

Using the HP 37717C in a *receive only* mode, each tributary is scanned and any alarm or BIP occurrence is flagged on the **RESULTS** display. If the fibre contains an unknown signal structure (mixed payloads) the HP 37717C will quickly determine and scan that structure.

Default (Known State) Settings

It can be advisable to set the HP 37717C to a known state prior to setting up to make a measurement. This clears all previous settings and provides a clearly defined instrument state. The default settings are set by selecting **OTHER STORED SETTINGS** STORED SETTING NUMBER 0 and pressing **RECALL**

Test Setup Procedure (Alarm Monitoring)

The following Options must be fitted to the HP 37717C to perform this test:

- UKJ or UKK PDH Module
- A3R [A3S] SDH Module
- 130 or 131 STM-1/4 Optical Interface

This setup procedure is based on STM-4 line traffic with mixed payload.

The instrument is used in a *receive only* mode to monitor Loss of Pointer, AU-AIS, HP-RDI, H4 Loss of Multiframe, TU-Loss Of Pointer, TU-AIS, LP-RDI alarms and BIP errors in AU-4, AU-3, TU-3, TU-2 and TU-12 payloads.

SDH Testing Automatic Alarm and BIP Error Monitoring



Alarm Monitoring

1. Connect the HP 37717C to the Network equipment via the optical splitter and set up the **RECEIVE SDH** display as shown opposite.

The MAPPING and TU PAYLOAD selections are only important if the Alarm Scan is to be carried out on the RX SETTINGS.

RECEIVER INPUT E SDH SDH STRUCT'D TEST OVERHEAD PRYLORD FUNCTION MONITOR	1	
SIGNAL [STM-4 OPT] STM-1 UNDER TEST [1 MAPPING RU-4 [TU-12][RSYNC 2Mb/s]	
SELECTED TU TUG3 [3] TUG2 [7] TU [TU PAYLOAD E PCM31CRC PATTERN (LIVETRAFFIC)	3]	
STATUS: 1000 USER LIVE WORD TRAFFIC	MORE	MULTIPLE WINDOW

2. Set up the **RESULTS SDH ALM SCAN** display as shown opposite.

AUTO configures the HP 37717C to determine the received payload structure and carry out an Alarm Scan in each tributary.

BIP [>0] configures the 37717C to detect any occurrence of a BIP error. A choice of BIP [>1E-3] or [>1E-6] or [OFF] is also available.



SDH Testing Automatic Alarm and BIP Error Monitoring

Start the Test (Alarm Monitoring)

1. Select **START** on the **RESULTS SDH ALM SCAN** display.

If any of the alarms, Loss of Pointer, AU-AIS, HP-RDI, H4 Loss of Multiframe, TU Loss of Pointer, TU-AIS or LP-RDI has occurred the appropriate point in the hierarchy will be highlighted.

If a BIP error has occurred in the AU-4, AU-3, TU-3, TU-2 or TU-12 payload the appropriate point in the hierarchy will be highlighted.

If Unequiped is identified, the apropriate point in the hierarchy will be changed to U.

The test can be halted at any time by selecting **STOP** on the **RESULTS SDH ALM SCAN** display.

Automatic Verification of ADM Installation

Application

An important part of the ADM installation process is the verification of path routing through an ADM (or Digital Cross Connect). In order to verify the routing of VC-n paths which are terminated by the network element, the mapped payload, dropped to a PDH tributary port, must be looped back at the digital distribution frame and mapped into the VC-n at the PDH tributary insert port. VC-n paths which are not terminated must be looped back at the STM-n level. Since an STM-1 contains 63 VC-12's and a STM-4 contains 252 VC-12's, manually checking each path is time consuming and laborious.

Using the HP 37717C Tributary Scan feature the installation of ADM's can be automated and any Bit errors or Pattern Sync Loss will be flagged on the **RESULTS** display.

Default (Known State) Settings

It can be advisable to set the HP 37717C to a known state prior to setting up to make a measurement. This clears all previous settings and provides a clearly defined instrument state. The default settings are set by selecting **OTHER STORED SETTINGS** STORED SETTING NUMBER 0 and pressing **RECALL**

Test Setup Procedure (Alarm Monitoring)

The following Options must be fitted to the HP 37717C to perform this test:

- UKJ or UKK PDH Module
- A3R [A3S]- SDH Module
- 130 or 131 STM-1/4 Optical Interface

This setup procedure is based on STM-4 with 252 TU-12 payloads.

The instrument generates a STM-4 signal with 252 TU-12 tributaries. The tributaries are mapped into the STM-4 received signal and scanned by the Tributary Scan for bit errors and Pattern Sync Loss.

The Parallel printer port is enabled and the Tributary Scan results are logged to a Centronics printer

SDH Testing Automatic Verification of ADM Installation



ADM Installation

1. Connect the HP 37717C to the ADM and set up the **OTHER** display as shown opposite.

Any changes made on the **TRANSMIT** or **RECEIVE** display will affect the other.

2. Connect a Centronics printer to the HP 37717C Parallel printer port.



3. Set up the **TRANSMIT SDH** display as shown below.

The MAPPING and TU PAYLOAD selections should reflect the mapping and TU payload employed in the ADM

TRRNSMITTER DUTPUT [SDH]	TRANSMITTER DUTPUT E SDH]
SOF STRUCT'D JITTER TEST OUEMERD	SDH STRUCTYO JITTER TEST DUEPHERD
PAR'LORD FUNCTION SETUP	PAYLORD FUNCTION SETUP
SLOWAL CENT4- OPTIC 1310 JEINTERNAL]	SIGNAL (STM-4 OPTJE 1310 JEINTENNAL]
CLOCK LEXT MTS DATA J OFFSET [OFF]	CLOCK LEXT WIS DATA] OFFSET [OFF]
MRPPING C HU-4 C FOREGROUND 1 2N OFFSET C RSYNC 2Nb/5 1 2N OFFSET C POPM 1 CHRNRCL STM-1 U OPPM 1 CHRNRCL STM-1 U C C C C C C C C C C C C C C C C C C C	RENERGROUND STM-1'S [FIXED] TUG3 NO.2 [TU3 MAP] MIXED PAYL TUG3 NO.3 [TU3 MAP] MIXED PAYL PATTERN IN OTHER TU12S [2^15-1 PRBS]
STATUS:	STRTUS:
Multiple	F/G MULTIPLE
Mindoa	MARPING MARPING NINDM

SDH Testing Automatic Verification of ADM Installation

4. Set up the **TRANSMIT** TEST

FUNCTION display as shown opposite.

The BIT ERROR THRESHOLD setting has three choices:

> 0 - Any bit error will highlight the tributary in error.

>1E-6 - Bit error rate greater than 1 in 10° will highlight the tributary in error.

>1E-3 - Bit error rate greater than 1 in 10[°] will highlight the tributary in error.

TRANSI SDH	STRUCT'D	T JITTER	E SDH TEST OVERH NCTION SETL] EAD P	
TEST F	UNCTION	RIB SCAN]	C STO	P]	
BIT EF	ROR THRESHO	LD	C > 0	3	
TEST '	IMING	SINGLE	E 10 SECS	3	
	SEE (G igs) Tributar	Tis) Page F Y Scan Res	DR ULTS		
STATUS:	SDH	PDH Payload	SDH TRIB SCRN	Î	MULTIPLE WINDOW

TEST TIMING determines the time taken to verify each tributary. If 10 seconds is selected, in this example 252 TU-12 tributaries, the test will take approximately 55 minutes.

Start the Test (ADM Installation)

1. Select **START** on the **RESULTS SDH TRIB SCAN** display.

The "flashing" message on the status line indicates that the SDH Tributary Scan is active.

For STM-4 signals only one STM-1 is displayed at a time. To view the other STM-1's select the required number 1, 2, 3 or 4 on the **RESULTS SDH TRIB SCAN** display.



A PRBS is inserted in each tributary. If Pattern Synchronization is not achieved in 3 seconds the relevant tributary is highlighted. A Bit error measurement is performed in each tributary. The timing of the measurement is determined by the TEST TIMING selection made on the **TRANSMIT** TEST FUNCTION display, in this example 10 Seconds. If the Bit error rate exceeds the BIT ERROR THRESHOLD selected on the **TRANSMIT** TEST FUNCTION display the relevant tributary is highlighted.

SDH Testing Automatic Verification of ADM Installation

2. Set up the **OTHER LOGGING** display as shown opposite.

PRINTER TYPE allows selection of HP printer or Alternative suppliers printer.

If [ALT. PRINTER] is selected a choice of **NORMAL** (80 column) or **COMPRESS** (40 column) is provided.

STATUS: Normal come	RESS				MULTIPLE Window
MODE		Ì	NORMAL		
PRINTER TYPE	L PURT	г		R1	
LOGGING PORT		C	PARALLEL	1	
LOGGING SETUP		[DEVICE	3	
FUNCTION	C	LOGGING		1	

3. Set up the **OTHER LOGGING** display as shown opposite.

LOG ON DEMAND [TRIB SCAN] ensures that the SDH Tributary Scan is logged to the Centronics printer when **PRINT NOW** is pressed.

At the end of the SDH Tributary Scan (the status line message is no longer "flashing") press **PRINT NOW** to log the results of all four STM-1's on the Centronics printer.

FUNCTION	E LOGGING	1
LOGGING SETUP	E CONTROL	3
LOGGING	[OFF	1
LOG ON DEMAND	(TRIB SCAN	
STATUS: RESULTS OVERHER SMARSHOT SMARSHO	D OVERHEAD POINTER	SDH TRIB MULTIPLE
		JEIN WINDOW

Verification of Protection Switching

Application

An important part of the installation process is the verification of protection switching mechanisms. Switching verification ensures that data integrity is maintained and revenue protected when equipment failure or fibre cuts occur. Measuring the speed of the network elements protection switch mechanism ensures data loss is minimized. The protection switch can be invoked by either removing the STM-n fibre or using the network management system to make the switch.

The protection switch times can then be measured using the HP 37717C's Service Disruption Time measurement. The measurement is made at the Path or Payload level carrying the actual service and therefore provides a real indication of the time the network takes to self heal.

Capability is also provided to invoke protection switching at the Multiplexer Section level using the K1K2 byte textual decodes otherwise known as MSP Message Generation. Both Linear Architecture MSP Messages as described in ITU-T G.783 and Ring Architecture MSPRing Messages as described in ITU-T G.841 are provided.

Default (Known State) Settings

It can be advisable to set the HP 37717C to a known state prior to setting up to make a measurement. This clears all previous settings and provides a clearly defined instrument state. The default settings are set by selecting **OTHER STORED SETTINGS** STORED SETTING NUMBER 0 and pressing **RECALL**

Test Setup Procedure (Verification of Protection Switching)

The following Options must be fitted to the HP 37717C to perform this test:

- UKJ or UKK PDH Module
- A3R [A3S] SDH Module
- 130 or 131 STM-1/4 Optical Interface

This setup procedure is based on STM-1 with Structured PDH payload.

The instrument generates a STM-1 signal with a structured payload with PRBS pattern. This is inserted into the network element. The Receiver locks on to the PRBS pattern. The management system is used to invoke the protection switching. At the time of switching, pattern synchronization will be lost and will not be regained until the standby line is in place. The time interval between pattern sync loss and pattern sync gain is a measure of the disruption of service due to protection switching. This is measured by the HP 37717C.



Protection Switching Verification

1. Connect the HP 37717C to the ADM and set up the OTHER display as shown opposite.	FUNCTION E SETTINGS CONTROL 3 TRANSMITTER AND RECEIVER COUPLED TO RECEIVER COUPLED TO TRANSMITTER	
Any changes made on the TRANSMIT or RECEIVE display will affect the other.		
	status: Irde=- Endent	MULTIPLE WINDOW
2. Set up the TRANSMIT SDH display as shown opposite.	TRANSMITTER DUTPUT C SDH J SDH STRUCT'D JITTER TEST DUERHERD PRVLORD FUNCTION SETUP SIGNAL (STM-1 OPT)C 1310 JINTERNAL J CLOCK CENT MTS DATH 3 DOFFSET C OFF J	
	MAPPING RU-4 E FOREGROUND] 140M OFFSET L UC-4] 140M OFFSET L O PPM] PRVLORD TYPE E STRUCTURED] TO STRUCT'D PAYLORD'FOLDER ABOVE.	
	STATUS:	MULTIPLE NINDON

3. Set up the **TRANSMIT** STRUCTURED PAYLOAD display as shown opposite.

TRANSMITTER OUTPUT SDH STRUCT D JITTER PAYLOAD	E SDH TEST OVERH UNCTION SETU] EAD P
TEST SIGNAL 2M PAYLOAD 34Mb 8Mb [3] [2]	[2 Mb/s [PCM30CRC 2Mb [4]]
PATTERN PRBS POLARITY B/G PATTERN	E 2^15-1 PRB E INV] ITU E AIS	s]]
2M CRS ABCD BITS	[1111	1
STATUS:		MULTIPLE Window

Start the Test (Protection Switch Verification)

Press **RUN/STOP** to start the test.

Check that pattern synchronization is achieved (no errors).

Invoke the protection switch using the network management system.

Set up the **RESULTS** display as shown opposite.

The Service Disruption result is displayed when pattern synchronization is regained.

LONGEST - Longest burst of errors during measurement. SHORTEST - Shortest burst of errors during measurement. LAST - Length of last burst of errors

detected during measurement.

RESULTS I SRUC DIS	RUPT]			
LONGEST		m	5	
SHORTEST		P1	5	
LAST		m	5	
ELAPSED TIME				
STATUS: PDH SERVICE ALM SCAN DISRUPT	SDH Alm Scan	SDH TRIB SCAN	MORE	MULTIPLE WINDOW

3

Result Definitions

Information about SDH resuilts.

Trouble Scan

All possible error sources and alarms are scanned simultaneously. If any error counts are not zero then these are displayed. Up to 4 non-zero error counts are displayed in priority order

UPDH (Option UKK[USB]	SDH (Option A3R [A3S]	SPDH (Option UKJ[USA])	ATM (Option UKN) + SDH	ATM (Option UKN) + SPDH
CRC BIT CODE FRAME REBE	RS B1 BIP or B1 BIP MS B2 BIP or B2 BIP Path B3 BIP or B3 BIP VC3 PATH BIP TU2 BIP A1A2 FRAME MS FEBE or MS REI PATH FEBE or HP REI PATH FEBE or HP REI TU2 FEBE or LP REI TU12 FEBE or LP REI BIT	CRC BIT CODE FAS 140M FAS 34M FAS 2M FAS 2M REBE	B1 BIP (SDH only) B2 BIP (SDH only) B3 BIP (SDH only) Non Corrected HEC Corrected HEC Lost Cells Misinserted Cells Path FEBE or REI Bit Errored Cells	EM BIP Non Corrected HEC Corrected HEC Lost Cells Misinserted Cells EM FEBE Bit Errored Cells

Error Count Priority

If any alarms are active "ALARMS ACTIVE" is displayed.

SHOW HISTORY and the alarm led's can be used to determine which alarms are active.

If no alarms are active and no non-zero error counts are detected then "NO TROUBLE" is displayed.

Error Summary

A summary of the short term / cumulative results as counts or ratios and optical power on one display.

Result Definitions Short Term Results

Short Term Results

Displays period results obtained during the measurement. The period is user-defined under SHORT TERM PERIOD on the **RESULTS** display. Many result parameters are presented in two forms: a count of error events (EC or COUNT) and a ratio of the number of errors to the total possible in the time period (ER or RATIO).

Error Count and Error Ratio results for the following error sources are available:

A1A2 FRAME	Compares the received Framing bytes with the known value.	
	(Option A1T[A1U] only)	
B1 BIP	Compares the received B1 with the recalculated value.	
B2 BIP	Compares the received B2 with the recalculated value.	
MS-REI	Calculated from the REI bits in the received M1 overhead byte.	
	(Option A1T[A1U] only)	
B3 BIP	Compares the received B3 with the recalculated value.	
HP-REI	Calculated from the REI bits in the received G1 overhead byte.	
HP-IEC	Calculated from the IEC bits in the received Z5 Path overhead	
	byte. (Option A1T[A1U] only)	

If a Payload of 34 Mb/s is selected, Error Count and Error Ratio results for the following additional error sources are also available:

TU BIP	Compares the received VC3, B3 with the recalculated value.
LP-REI	Calculated from the FEBE bits in the received VC3, G1 over-
	head byte.

If a Payload of 2 Mb/s is selected, Error Count and Error Ratio results for the following additional error sources are also available:

TU BIP	Compares the received V5, BIP-2 in the TU12 selected for test
	with the recalculated value.
LP-REI	Calculated from the FEBE bits in the V5 overhead byte of the
	TU12 selected for test.

Cumulative Results

Provides a cumulative display of the results during the measurement period. Many result parameters are presented in two forms: a count of error events (EC or COUNT) and a ratio of the number of errors to the total possible in the time period (ER or RATIO).

Error Count and Error Ratio results for the following error sources are available:

A1A2 FRAME	Compares the received Framing bytes with the known value.	
	(Option A1T[A1U] only)	
B1 BIP	Compares the received B1 with the recalculated value.	
B2 BIP	Compares the received B2 with the recalculated value.	
MS-REI	Calculated from the REI bits in the received M1 overhead byte.	
	(Option A1T[A1U] only)	
B3 BIP	Compares the received B3 with the recalculated value.	
HP-REI	Calculated from the REI bits in the received G1 overhead byte.	
HP-IEC	Calculated from the PIEC bits in the received Z5 Path overhead	
	byte. (Option A1T[A1U] only)	

If a Payload of 34 Mb/s is selected, Error Count and Error Ratio results for the following additional error sources are also available:

TU BIP	Compares the received VC3, B3 with the recalculated value.
LP-REI	Calculated from the FEBE bits in the received VC3, G1 over-
	head byte.

If a Payload of 2 Mb/s is selected, Error Count and Error Ratio results for the following additional error sources are also available:

TU BIP	Compares the received V5, BIP-2 in the TU12 selected for test
	with the recalculated value.
LP-REI	Calculated from the FEBE bits in the V5 overhead byte of the
	TU12 selected for test.
Result Definitions SDH Error Analysis

SDH Error Analysis

Analysis results are calculated for the following error sources:

B1 BIP; B2 BIP; MS-REI; B3 BIP; HP-REI and HP-IEC. If a Payload of 34 Mb/s or 2 Mb/s is selected additional error sources of TU BIP and LP-REI are also available.

G.826 Analysis B1 BIP

These calculations are based on "Errored Blocks". A Block is a set of consecutive bits associated with the Path. Each bit belongs to one and only one block. If an STM-4 interface is selected an errored block is a BIP with one or more bits in error.

Table 3-1 G.826 Analysis B1 BIP

Display	Definition		
ES	Errored Seconds - Cumulative count of 1 second periods that contain at least 1 Errored Block.		
EB	Errored Block count - cumulative count of errored blocks.		
SES	Severely errored Seconds - Cumulative count of 1 second periods with >= 2400 Errored Blocks, or containing a "defect". Defects are LOS and LOF.		
UNAV	Unavailability - Cumulative count of unavailable seconds. A period of unavailability begins at the start of 10 or more consecutive severely errored seconds, and ends at the start of 10 or more consecutive non severely errored seconds.		
ESR	Error Second Ratio - The ratio of errored seconds to the total seconds of available time. A period of unavailability begins at the start of 10 or more consecutive Severely Errored Seconds, and ends at the start of 10 or more non Severely Errored Seconds.		
SESR	Severely Errored Second Ratio - The ratio of severely errored seconds to the total seconds of available time.		
BBEC	Background Block error count - Cumulative count of errored blocks which occur outwith a severely errored second.		
BBER	Background Block error Ratio - The ratio of errored blocks to total blocks. Total blocks excludes severely errored seconds and periods of unavailability.		

G.826 Analysis B2 BIP

These calculations are based on "Errored Blocks". A Block is a set of consecutive bits associated with the Path. Each bit belongs to one and only one block. If an STM-4 interface is selected an errored block is a BIP with one or more bits in error.

Table 3-2G.826 Analysis MS B2 BIP

Display	Definition	
ES	Errored Seconds - Cumulative count of 1 second periods that contain at least 1 Errored Block.	
EB	Errored Block count - cumulative count of errored blocks.	
SES	Severely errored Seconds - Cumulative count of 1 second periods with >= 2400 Errored Blocks, or containing a "defect". Defects are LOS, LOF and MS-AIS.	
UNAV	Unavailability - Cumulative count of unavailable seconds. A period of unavailability begins at the start of 10 or more consecutive severely errored seconds, and ends at the start of 10 or more consecutive non severely errored seconds.	
ESR	Error Second Ratio - The ratio of errored seconds to the total seconds of available time. A period of unavailability begins at the start of 10 or more consecutive Severely Errored Seconds, and ends at the start of 10 or more non Severely Errored Seconds.	
SESR	Severely Errored Second Ratio - The ratio of severely errored seconds to the total seconds of available time.	
BBEC	Background Block error count - Cumulative count of errored blocks which occur outwith a severely errored second.	
BBER	Background Block error Ratio - The ratio of errored blocks to total blocks. Total blocks excludes severely errored seconds and periods of unavailability.	

Result Definitions **SDH Error Analysis**

G.826 Analysis MS-REI

These calculations are based on "Errored Blocks". A Block is a set of consecutive bits associated with the Path. Each bit belongs to one and only one block. If an STM-4 interface is selected an errored block is a REI with one or more bits in error.

Table 3-3 G.826 Analysis MS-REI

Display	Definition	
ES	Errored Seconds - Cumulative count of 1 second periods that contain at least 1 Errored Block.	
EB	Errored Block count - cumulative count of errored blocks.	
SES	Severely errored Seconds - Cumulative count of 1 second periods with >= 2400 Errored Blocks, or MS-RDI.	
UNAV	Unavailability - Cumulative count of unavailable seconds. A period of unavailability begins at the start of 10 or more consecutive severely errored seconds, and ends at the start of 10 or more consecutive non severely errored seconds.	
ESR	Error Second Ratio - The ratio of errored seconds to the total seconds of available time. A period of unavailability begins at the start of 10 or more consecutive Severely Errored Seconds, and ends at the start of 10 or more non Severely Errored Seconds.	
SESR	Severely Errored Second Ratio - The ratio of severely errored seconds to the total seconds of available time.	
BBEC	Background Block error count - Cumulative count of errored blocks which occur outwith a severely errored second.	
BBER	Background Block error Ratio - The ratio of errored blocks to total blocks.Total blocks excludes severely errored seconds and periods of unavailability.	

NOTE

Near End Failures of LOS, LOF and MS-AIS produce "dead time" in the MS-REI measurement such that result accumulation is suspended.

G.826 B3 BIP Analysis

These calculations are based on "Errored Blocks". A Block is a set of consecutive bits associated with the Path. Each bit belongs to one and only one block.

Table 3-4G.826 Analysis B3 BIP

Display	Definition
ES	Errored Seconds - Cumulative count of 1 second periods that contain at least 1 Errored Block.
EB	Errored Block count - cumulative count of errored blocks.
SES	Severely errored Seconds - Cumulative count of 1 second periods with >= 2400 Errored Blocks, or containing a "defect". Defects are LOS, LOF, MS-AIS, LOP and AU-AIS.
UNAV	Unavailability - Cumulative count of unavailable seconds. A period of unavailability begins at the start of 10 or more consecutive severely errored seconds, and ends at the start of 10 or more consecutive non severely errored seconds.
ESR	Error Second Ratio - The ratio of errored seconds to the total seconds of available time. A period of unavailability begins at the start of 10 or more consecutive Severely Errored Seconds, and ends at the start of 10 or more non Severely Errored Seconds.
SESR	Severely Errored Second Ratio - The ratio of severely errored seconds to the total seconds of available time.
BBEC	Background Block error count - Cumulative count of errored blocks which occur outwith a severely errored second.
BBER	Background Block error Ratio - The ratio of errored blocks to total blocks. Total blocks excludes severely errored seconds and periods of unavailability.
PUAS	Path Unavailable Second count - Logical OR of the Near and Far end unavailable seconds.

Result Definitions **SDH Error Analysis**

G.826 HP-REI Analysis

These calculations are based on "Errored Blocks". A Block is a set of consecutive bits associated with the Path. Each bit belongs to one and only one block.

Table 3-5G.826 Analysis HP-REI

Display	Definition			
ES	Errored Seconds - Cumulative count of 1 second periods that contain at least 1 Errored Block.			
EB	Errored Block count - cumulative count of errored blocks.			
SES	Severely errored Seconds - Cumulative count of 1 second periods with >= 2400 Errored Blocks, or HP-RDI.			
UNAV	Unavailability - Cumulative count of unavailable seconds. A period of unavailability begins at the start of 10 or more consecutive severely errored seconds, and ends at the start of 10 or more consecutive non severely errored seconds.			
ESR	Error Second Ratio - The ratio of errored seconds to the total seconds of available time. A period of unavailability begins at the start of 10 or more consecutive Severely Errored Seconds, and ends at the start of 10 or more non Severely Errored Seconds.			
SESR	Severely Errored Second Ratio - The ratio of severely errored seconds tot he total seconds of available time.			
BBEC	Background Block error count - Cumulative count of errored blocks which occur outwith a severely errored second.			
BBER	Background Block error Ratio - The ratio of errored blocks to total blocks. Total blocks excludes severely errored seconds and periods of unavailability.			
PUAS	Path Unavailable Second count - Logical OR of the Near and Far end unavailable seconds.			

NOTE

Near End Failures of LOS, LOF, MS-AIS, AU-LOP and AU-AIS produce "dead time" in the HP-REI measurement such that result accumulation is suspended.

G.826 HP-IEC Analysis

These calculations are based on "Errored Blocks". A Block is a set of consecutive bits associated with the Path. Each bit belongs to one and only one block.

Table 3-6G.826 Analysis HP-IEC

Display	Definition
ES	Errored Seconds - Cumulative count of 1 second periods that contain at least 1 Errored Block.
EB	Errored Block count - cumulative count of errored blocks.
SES	Severely errored Seconds - Cumulative count of 1 second periods with >= 2400 Errored Blocks, or containing a "defect". Defects are LOS, LOF, MS-AIS, LOP, AU-AIS and HP-RDI.
UNAV	Unavailability - Cumulative count of unavailable seconds. A period of unavailability begins at the start of 10 or more consecutive severely errored seconds, and ends at the start of 10 or more consecutive non severely errored seconds.
ESR	Error Second Ratio - The ratio of errored seconds to the total seconds of available time. A period of unavailability begins at the start of 10 or more consecutive Severely Errored Seconds, and ends at the start of 10 or more non Severely Errored Seconds.
SESR	Severely Errored Second Ratio - The ratio of severely errored seconds to the total seconds of available time.
BBEC	Background Block error count - Cumulative count of errored blocks which occur outwith a severely errored second.
BBER	Background Block error Ratio - The ratio of errored blocks to total blocks.Total blocks excludes severely errored seconds and periods of unavailability.
PUAS	Path Unavailable Second count - Logical OR of the Near and Far end unavailable seconds.

NOTE

Near End Failures of LOS, LOF, MS-AIS, AU-LOP and AU-AIS produce "dead time" in the HP-IEC measurement such that result accumulation is suspended.

G.826 TU BIP Analysis - 34 Mb/s Payload

These calculations are based on "Errored Blocks". A Block is a set of consecutive bits associated with the Path. Each bit belongs to one and only one block.

Table 3-7G.826 Analysis TU BIP - 34 Mb/s Payload

Display	Definition		
ES	Errored Seconds - Cumulative count of 1 second periods that contain at least 1 Errored Block.		
EB	Errored Block count - cumulative count of errored blocks.		
SES	Severely errored Seconds - Cumulative count of 1 second periods with >= 2400 Errored Blocks, or containing a "defect". Defects are LOS, LOF, MS AIS, LOP, AU-AIS, H4 LOM, TU3-AIS and TU3-LOP.		
UNAV	Unavailability - Cumulative count of unavailable seconds. A period of unavailability begins at the start of 10 or more consecutive severely errored seconds, and ends at the start of 10 or more consecutive non severely errored seconds.		
ESR	Error Second Ratio - The ratio of errored seconds to the total seconds of available time. A period of unavailability begins at the start of 10 or more consecutive Severely Errored Seconds, and ends at the start of 10 or more non Severely Errored Seconds.		
SESR	Severely Errored Second Ratio - The ratio of severely errored seconds to the total seconds of available time.		
BBEC	Background Block error count - Cumulative count of errored blocks which occur outwith a severely errored second.		
BBER	Background Block error Ratio - The ratio of errored blocks to total blocks.Total blocks excludes severely errored seconds and periods of unavailability.		
PUAS	Path Unavailable Second count - Logical OR of the Near and Far end unavailable seconds.		

G.826 TU BIP Analysis - 2 Mb/s Payload

These calculations are based on "Errored Blocks". A Block is a set of consecutive bits associated with the Path. Each bit belongs to one and only one block.

Table 3-8G.826 Analysis TU BIP - 2 Mb/s Payload

Display	Definition		
ES	Errored Seconds - Cumulative count of 1 second periods that contain at least 1 Errored Block.		
ЕВ	Errored Block count - cumulative count of errored blocks.		
SES	Severely errored Seconds - Cumulative count of 1 second periods with >= 600 Errored Blocks, or containing a "defect". Defects are LOS, LOF, MS AIS, LOP, AU-AIS, H4 LOM, TU-IS and TU-LOP.		
UNAV	Unavailability - Cumulative count of unavailable seconds. A period of unavailability begins at the start of 10 or more consecutive severely errored seconds, and ends at the start of 10 or more consecutive non severely errored seconds.		
ESR	Error Second Ratio - The ratio of errored seconds to the total seconds of available time. A period of unavailability begins at the start of 10 or more consecutive Severely Errored Seconds, and ends at the start of 10 or more non Severely Errored Seconds.		
SESR	Severely Errored Second Ratio - The ratio of severely errored seconds to the total seconds of available time.		
BBEC	Background Block error count - Cumulative count of errored blocks which occur outwith a severely errored second.		
BBER	Background Block error Ratio - The ratio of errored blocks to total blocks. Total blocks excludes severely errored seconds and periods of unavailability.		
PUAS	Path Unavailable Second count - Logical OR of the Near and Far end unavailable seconds.		

G.826 LP-REI Analysis - 34 Mb/s Payload

These calculations are based on "Errored Blocks". A Block is a set of consecutive bits associated with the Path. Each bit belongs to one and only one block.

Table 3-9 G.826 Analysis LP-REI, 34 Mb/s Payload

Display	Definition		
ES	Errored Seconds - Cumulative count of 1 second periods that contain at least 1 Errored Block.		
EB	Errored Block count - cumulative count of errored blocks.		
SES	Severely errored Seconds - Cumulative count of 1 second periods with >= 2400 Errored Blocks, or LP-RDI.		
UNAV	Unavailability - Cumulative count of unavailable seconds. A period of unavailability begins at the start of 10 or more consecutive severely errored seconds, and ends at the start of 10 or more consecutive non severely errored seconds.		
ESR	Error Second Ratio - The ratio of errored seconds to the total seconds of available time. A period of unavailability begins at the start of 10 or more consecutive Severely Errored Seconds, and ends at the start of 10 or more non Severely Errored Seconds.		
SESR	Severely Errored Second Ratio - The ratio of severely errored seconds to the total seconds of available time.		
BBEC	Background Block error count - Cumulative count of errored blocks which occur outwith a severely errored second.		
BBER	Background Block error Ratio - The ratio of errored blocks to total blocks. Total blocks excludes severely errored seconds and periods of unavailability.		
PUAS	Path Unavailable Second count - Logical OR of the Near and Far end unavailable seconds.		

NOTE

Near End Failures of LOS, LOF, MS-AIS, AU-LOP, AU-AIS, H4 LOM, TU-LOP and TU-AIS produce "dead time" in the LP-REI measurement such that result accumulation is suspended.

G.826 LP-REI Analysis - 2 Mb/s Payload

These calculations are based on "Errored Blocks". A Block is a set of consecutive bits associated with the Path. Each bit belongs to one and only one block.

Table 3-10G.826 Analysis LP-REI - 2 Mb/s Payload

Display	Definition	
ES	Errored Seconds - Cumulative count of 1 second periods that contain at least 1 Errored Block.	
EB	Errored Block count - cumulative count of errored blocks.	
SES	Severely errored Seconds - Cumulative count of 1 second periods with >= 600 Errored Blocks, or TU3 Path FERF .	
UNAV	Unavailability - Cumulative count of unavailable seconds. A period of unavailability begins at the start of 10 or more consecutive severely errored seconds, and ends at the start of 10 or more consecutive non severely errored seconds.	
ESR	Error Second Ratio - The ratio of errored seconds to the total seconds of available time. A period of unavailability begins at the start of 10 or more consecutive Severely Errored Seconds, and ends at the start of 10 or more non Severely Errored Seconds.	
SESR	Severely Errored Second Ratio - The ratio of severely errored seconds to the total seconds of available time.	
BBEC	Background Block error count - Cumulative count of errored blocks which occur outwith a severely errored second.	
BBER	Background Block error Ratio - The ratio of errored blocks to total blocks.Total blocks excludes severely errored seconds and periods of unavailability.	
PUAS	Path Unavailable Second count - Logical OR of the Near and Far end unavailable seconds.	

NOTE

Near End Failures of LOS, LOF, MS-AIS, AU-LOP, AU-AIS, H4 LOM, TU-LOP and TU-AIS produce "dead time" in the LP-REI measurement such that result accumulation is suspended.

SDH Pointer Value Results

Table 3-11	Pointer Value
Display	Definition
Pointer Value	The received Pointer value.
NDF	The number of seconds containing one or more active New Data Flag
Missing NDF	The number of seconds containing one or more VC moves with no accompanying active New Data Flag.
POS ADJUSTMENTS	The number of positive pointer adjustments in the measurement period and the number of seconds in the measurement period which contain one or more positive adjustments.
NEG ADJUSTMENTS	The number of negative pointer adjustments in the measurement period and the number of seconds in the measurement period which contain one or more negative adjustments.
IMPLIED VC4 OFFSET	The total number of positive and negative pointer movements during the measurement are counted and the implied mean VC offset, is calculated in ppm.

Result Definitions **SDH Pointer Value Results**

SDH Alarm Seconds

Table 3-12SDH Alarm Seconds

Alarm	Payload	STM-1	STM-4
Power Loss	Yes	Yes	Yes
Loss of Signal (LOS)	Yes	Yes	Yes
Loss of Frame (LOF)	Yes	Yes	Yes
Out of Frame (OOF)	Yes	Yes	Yes
Loss of Pointer (AU-LOP)	Yes	Yes	No
MS-AIS	Yes	Yes	Yes
K1K2 Change (A1T[A1U] only)	Yes	Yes	Yes
AU-AIS	Yes	Yes	No
MS-RDI	Yes	Yes	Yes
HP-RDI	Yes	Yes	No
H4 LOM	Not 140 Mb/s Payload	No	No
TU-LOP	Not 140 Mb/s Payload	No	No
TU-AIS	Not 140 Mb/s Payload	No	No
LP-RDI	Not 140 Mb/s Payload	No	No

Result Definitions
Frequency Measurement

Frequency Measurement

Frequency measurement is available at standard PDH and SDH rates. The measured frequency is displayed in Hz with 1 Hz resolution. Offset from the standard rate is displayed in Hz and ppm (parts per million).

Optical Power

Optical Power measurement is available for SDH optical signals.

The received optical power, 0 to -30dBm is displayed with an accuracy of ± 1 dB.

Result Definitions
Optical Power

SDH Logging Messages

Logging Devices

Results may be logged to the Disc Drive. A bit map of graphics results can be recorded on the disk drive by using the screen dump feature.

If Remote Control Option A3X is fitted, results may be logged to the Internal Printer.

If Remote Control Option A3B or A3D, is fitted the following types of External printer can be used for results logging:

- HP-IB HP 550C DeskJet printer
- RS-232-C HP 550C DeskJet printer
- An alternative suppliers RS-232-C printer

The alternative suppliers RS-232-C printer can be 40 column width or 80 column width. If a 40 column width printer is used Graphics results cannot be logged.

• A Centronics parallel printer

Results Logging

Header and results are logged to the selected device when:

- **PRINT NOW** is pressed.
- If LOGGING [ON] is selected on the **OTHER LOGGING** display and a measurement is started by pressing **RUN/STOP**

= = = = = = = = = = = = = = = = = = =		======							
Hewlett Packard HP37717C									
Instrument Configuration									
RECEIVER									
Receive Signal	:	STM-1	ELEC	CTRICAL					
Level	:	TERMIN	ATE						
Mapping	:	AU-4	7	/C-4	140 Mb/s				
Payload Type	:	UNFRAM	ED						
Pattern	:	2^23-1			Polarity	:	INVERTED		
MEASUREMENT STARTED		23 Jul	97	10:27:13	Pri	nt Period	10 Minutes		

Logging Header Example

If **PRINT NOW** is pressed the cumulative results are logged. If a measurement is in progress the current results are logged. If a measurement is not in progress the cumulative results for the last measurement are logged.

During the Measurement Period

If LOG ERROR SECOND [ON] is selected on the **OTHER** LOGGING display all occurrences of an Error Second will be logged:

- Bit
- Code (PDH)
- Frame (PDH)
- CRC (PDH)
- REBE (PDH)
- DS3 Frame (SDH)
- DS3 P-Bit (SDH)

- DS3 C-Bit (SDH)
- DS3 FEBE (SDH)
- DS1 Frame (SDH)
- DS1 CRC6 (SDH)
- A1A2 FRAME (SDH)
- RS B1 BIP/B1 BIP (SDH)
- MS B2 BIP/B2 BIP (SDH)
- MS FEBE/RS REI (SDH)
- Path B3 BIP/B3 BIP (SDH)
- Path FEBE/HP REI (SDH)
- Path IEC/HP IEC (SDH)
- TU Path BIP (SDH)
- TU Path FEBE/LP REI (SDH)
- Hit Count (Jitter)
- Hit seconds (Jitter)
- Positive Peak Amplitude (Jitter)
- Negative Peak Amplitude (Jitter)
- Peak to Peak Amplitude (Jitter)
- RMS Amplitude (Jitter)
- Positive Peak (2Mb/s Wander)
- Negative Peak (2Mb/s Wander)
- Peak to Peak (2Mb/s Wander)
- Peak to Peak (15 min) (2Mb/s Wander)
- Peak to Peak (24 hours) (2Mb/s Wander)
- Time Interval Error (2Mb/s Wander)
- Estimated Bit Slips (2Mb/s Wander)
- Estimated Frame Slips (2Mb/s Wander)
- EM BIP (ATM)

- FEBE/REI (ATM)
- Corrected HEC (ATM)
- Non Corrected HEC (ATM)
- Cell Loss (ATM)
- Errored Cells (ATM)
- Misinserted Cells (ATM)

All Alarm occurrences will be logged both when set and cleared:

- Signal Loss
- AIS (PDH & ATM)
- Pattern Sync Loss (PDH & ATM)
- Loss Of Frame (SDH, PDH & ATM)
- Out Of Frame (SDH)
- Multiframe (PDH)
- Remote Loss (PDH)
- Remote Multiframe Loss (PDH)
- Loss of Pointer (SDH)
- MS AIS (SDH)
- Path AIS/AU AIS (SDH)
- Pattern Loss (SDH)
- Clock Loss (SDH)
- MS FERF/MS RDI (SDH)
- Path FERF/HP RDI (SDH)
- K1K2 Change (SDH)
- H4 Multiframe Loss (SDH)
- TU Loss of Pointer (SDH)
- TU AIS (SDH)
- TU Path FERF/LP RDI (SDH)
- DS3 Frame Loss (SDH)

- DS3 AIS (SDH)
- DS3 FERF (SDH)
- DS1 Frame Loss (SDH)
- DS1 AIS (SDH)
- DS1 FERF (SDH)
- Jitter Lock Loss (Option UHN[US9])
- Excess Jitter (Option UHN[US9])
- Excess Wander (Option UHN[US9])
- Wander Ref Loss (Option UHN[US9])
- Wander Signal Loss (Option UHN[US9])
- FERF/RDI (ATM)
- Loss of Cell Sync (ATM)
- Selected Cell Not Received (ATM)
- Congestion Experienced (ATM)
- Test Cell Loss (ATM)
- VP AIS (ATM)
- VP FERF/VP RDI (ATM)
- VC AIS (ATM)
- VC FERF/VC RDI (ATM)

In addition the following events are logged:

- All Alarms Clear
- Power Failure
- Power Restored
- New Day
- Squelched Printing stopped to conserve paper during period of Unavailability
- Unsquelched Printing restarted after period of Unavailability
- Print Demanded if **PRINT NOW** is pressed.

- Print Period if selected on **OTHER LOGGING** display.
- Printing Enabled if Printer enabled during a measurement.
- Measurement Complete

	10:27:32	LOS		SET	
ĺ	10:27:32	LOF		SET	
İ	10:27:32	OOF		SET	
İ	10:27:32	AU-LOP		SET	
ĺ	10:27:32	Pattern	Loss	SET	
İ	10:27:35	LOS		CLEAR	
ĺ	10:27:35	LOF		CLEAR	
ĺ	10:27:35	OOF		CLEAR	
ĺ	10:27:35	AU-LOP		CLEAR	
	10:27:35	Pattern	Loss	CLEAR	
	10:27:35	OOF		SET	
	10:27:35	OOF		CLEAR	
	10:27:35			ALL ALARMS	CLEAR
	10:27:36	Pattern	Loss	SET	
	10:27:36	Pattern	Loss	CLEAR	
	10:27:37			ALL ALARMS	CLEAR
	10:27:41	OOF		SET	
	10:27:41	OOF		CLEAR	
	10:27:42	Pattern	Loss	SET	
	10:27:42	Pattern	Loss	CLEAR	
	10:27:42			ALL ALARMS	CLEAR
	10:27:44	OOF		SET	
	10:27:44	OOF		CLEAR	
	10:27:45	Pattern	Loss	SET	
	10:27:45	Pattern	Loss	CLEAR	
	10:27:46			ALL ALARMS	CLEAR
	10:28:42	LOS		SET	
	10:28:42	LOF		SET	
	10:28:42	OOF		SET	
	10:28:42	AU-LOP		SET	
	10:28:42	Pattern	Loss	SET	
	10:28:44	LOS		CLEAR	
	10:28:44	LOF		CLEAR	
	10:28:44	OOF		CLEAR	
	10:28:44	AU-LOP		CLEAR	
	10:28:44	Pattern	Loss	CLEAR	
	10:28:44	OOF		SET	
	10:28:44	OOF		CLEAR	
	10:28:44			ALL ALARMS	CLEAR
	10:28:45	Pattern	Loss	SET	
	10:28:45	Pattern	Loss	CLEAR	
	10:28:46			ALL ALARMS	CLEAR

Logging During Measurement Example

At the End of the Measurement Period

A complete set of measurement results are logged.

BEASUREMENT COMPLETE 23 Jul 97 10:28:57 Elapsed Time Odd 00h 01m 4 Cumulative Results Cumulative Results Cumulative Results Cumulative Results Cumulative Results Not 00 00h 01m 4 Cumulative Results Cumulative Results Partor Count 393 307 1.065E-05 HP- PTO LP- TU LP- TU LP- TU TO Count 69 2.39895 N/A N/A STOR Count LP- TU LP- Trore Count 2.46326 ANALYSIS RS B1 MS D2 MS- PATH F Trored Blocks 6 6 6 Trored Blocks SUSSE-02 <th< th=""><th></th><th></th><th></th><th>=============</th><th></th><th></th></th<>				=============		
Cumulative Results AlA2 RS EI MS E2 MS- FRAME PATP PATH F FRAME BIT BTP REI BIP Curo Count 393 93 307 1.065E+06 24420 Error Count 9.860E-06 5.761E-09 1.923E-08 6.965E-05 1.565E-0 HP- HP- TU LP- KEI TCC DIP Stror Count 6.9 2339895 N/A N/A N/A Stror Count 4.617E-09 1.022E-05 N/A N/A N/A Stror Ratio 1.605E-05 N/A N/A N/A N/A Stror Count 6.9 233695 N/A N/A N/A Stror Ratio 1.704E-02 N/A N/A N/A Analysis Results : RS B1 MS B2 MS- PATH F Strored Seconds 10 10 10 10 10 Strored Seconds 0 0 0 0	MEASUREMENT COMPLE	TE 23 Jul	97 10:28:57	Elapsed	Time 00d	00h 01m 4
Ala2 RS B1 MS B2 MS- MS- MS- PRAME PATH F BIP BIP BIP REI BIP Error Count 393 93 307 1.065E+06 24422 Error Ratio 9.860B-06 5.761E-09 1.923E-08 6.965E-05 1.565E-0 HP- HP- TU LP- BIP REI Stror Count 69 239895 N/A N/A Stror Ratio 4.617E-09 1.605E-05 N/A N/A Stror Count 2.463E+08 N/A N/A N/A Analysis Results: G.826 ANALYSIS CCCC REI Severely Errored Seconds 10 10 10 10 Strored Seconds 0 0 0 10 10 Strored Seconds 10 10 10 10 10 Strored Seconds 0 0 0 0 10 Strored Seconds 10 12215 N/A N/A			Cumulative Re	sults		
AlA2 RS B1 MS B2 MS-PATH I FFAME BIP BIP REI BIP Error Count 333 93 307 1.0558+06 24422 Error Ratio 9.860E-06 5.761E-09 1.923E-08 6.965E-05 1.565E-0 HP- HP- TU LP- REI IEC BIP REI Stror Ratio 4.617E-09 1.605E-05 N/A N/A N/A Error Count 2.4632+08 N/A N/A N/A N/A Analysis Results : G.826 ANLYSIS REI BIP BIP REI BIP Strore Ratio 1.704E-02 N/A N/A N/A Analysis Results : G.826 ANLYSIS RS B1 MS B2 MS- PATH B Strored Seconds 10 10 10 10 10 Strored Seconds 10 10 10 10 10 Strored Seconds N/A 0 0	Error Results .					
FRAME BIP Constant 2333 93 307 1.0658+06 24420 Error Ratio 9.860B-05 5.761E-09 1.923B-08 6.9658-05 1.5658-05 1.5658-05 Arror Count 69 239895 N/A N/A N/A Stror Count 4.617B-09 1.6058-05 N/A N/A N/A Stror Ratio 1.704E-02 N/A N/A N/A N/A Analysis Results :	Lifer Reputer .	2122	RS B1	MS B2	MS-	ратн в
Initial Dia Dia <thdia< th=""> <thdia< <="" td=""><td></td><td>FDAME</td><td>BTD</td><td>BTD</td><td>DET</td><td>BTD</td></thdia<></thdia<>		FDAME	BTD	BTD	DET	BTD
And Count 9.860E-05 5.761E-09 1.925-08 6.965E-05 1.565E-05 HP- HP- TU LP- RET IEC BIP RET Count 69 239895 N/A N/A Stror Ratio 4.617E-09 1.605E-05 N/A N/A Stror Ratio 4.617E-09 1.605E-05 N/A N/A Analysis Results : G.826 ANALYSIS CCCC RET Strored Seconds 10 10 10 20 Strored Seconds 6 6 9 20 Strored Seconds 10 10 10 20 Strored Seconds 0 0 0 20 Strored Seconds 1.0 10 10 21 Strored Seconds 1.709E-02 9.709E-02 1.7048E-0 3.786E-02 1.748E-0 Sackground Block Errors 14 16 1.0474 1.541E-0 Strored Seconds 10 12155 N/A N/A<	Error Count	303	03	307	1 0658+06	24420
HP- HP- TU LP- REI IEC BIP REI Stror Count 69 239895 N/A N/A Stror Ratio 4.617E-09 1.605E-05 N/A N/A Stror Count 2.463E+08 N/A N/A N/A Stror Count 2.463E+08 N/A N/A N/A Analysis Results : G.826 ANALYSIS G.826 ANALYSIS Strored Seconds 10 10 10 23 Severely Errored Seconds 10 10 10 23 64000 7970 Severely Errored Seconds 10 10 10 23 23 64000 23 Severely Errored Seconds 10 10 10 23 23 24 20 23 6400 23 6400 23 24 20 23 6400 23 24 20 23 23 23 23 23 23 23 23 23 23 23	Error Ratio	9.860E-06	5.761E-09	1.923E-08	6.965E-05	1.565E-0
HP- HP- TU LP- REI IEC BIP REI Error Count 69 239895 N/A N/A Error Ratio 4.617E-09 1.605E-05 N/A N/A Error Count 2.463E+08 N/A N/A N/A Error Count 2.463E+08 N/A N/A N/A Analysis Results : G.826 ANALYSIS RS B1 MS B2 MS- PATH H Errored Seconds 10 10 10 10 3 Severely Errored Seconds 6 6 9 1 Arath Unavailable Seconds 0 0 0 Background Block Errors 14 16 1 1047 Strored Seconds 4 3 N/A N/A Strored Seconds 10 122155 N/A N/A Strored Seconds 10 122155 N/A N/A Strored Seconds 4 3 N/A N/A <t< td=""><td></td><td></td><td></td><td></td><td></td><td></td></t<>						
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Error Count 69 239895 N/A N/A Error Ratio 4.617E-09 1.605E-05 N/A N/A Error Ratio 4.617E-09 1.605E-05 N/A N/A Stror Ratio 1.704E-02 N/A N/A N/A Analysis Results : G.826 ANALYSIS RS B1 MS B2 MS- PATH F Errored Elocks Strored Seconds 10 10 10 3 Severely Errored Seconds 6 6 9 3 Davailable Seconds 0 0 0 0 Parth Unavailable Seconds N/A 0 0 0 Partored Seconds Errors 14 16 1 1047 Strored Seconds Atio 9.709E-02 9.708E-02 1.748E-0 Sackground Block Errors 14 16 1 1047 Strored Seconds 0 0 N/A N/A Severely Errored Sec Ratio 5.825E-02 9.278E-02 1.748E-0 Severely Errored Sec		REI	IEC	BIP	REI	
Error Ratio 4.61/E-09 1.605E-05 N/A N/A BIT (test) CODE CRC REE Stror Ratio 1.704E-02 N/A N/A N/A Analysis Results : G.826 ANALYSIS G.826 ANALYSIS Strore Ratio Strore Ratio N/A N/A N/A Strored Sconds 10 10 10 10 10 10 Strored Sconds 10 10 10 10 10 10 Strored Sconds 0 0 0 0 10 <t< td=""><td>Error Count</td><td>69</td><td>239895</td><td>N/A</td><td>N/A</td><td></td></t<>	Error Count	69	239895	N/A	N/A	
BIT (test) CODE CRC REE Error Ratio 2.463E+08 N/A N/A N/A Analysis Results :	Error Ratio	4.617E-09	1.605E-05	N/A	N/A	
Error Count 2.463E+08 N/A N/A N/A Srror Ratio 1.704E-02 N/A N/A N/A Analysis Results :			BIT (test)	CODE	CRC	REE
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Analysis Results : G.826 ANALYSIS RS B1 MS B2 MS- PATH BIP BIP BIP BIP REI BIP Severely Errored Seconds 10 10 10 10 Sackground Block Errors 14 16 1047 1045 Severely Errored Seconds 9.709E-02 9.709E-02 1.031E-01 3.786E-0 Sackground Block Errors 14 16 1047 Serored Second Ratio 9.709E-02 9.278E-02 1.748E-0 Sackground Block Err Ratio 1.804E-05 2.062E-05 1.420E-06 1.541E-0 Sackground Block Err Ratio 1.804E-05 2.062E-05 1.420E-06 1.541E-0 Severely Errored Seconds 4 3 N/A N/A Severely Errored Seconds 0 0 N/A N/A Severely Errored Seconds 0 19 N/A N/A Severely Errored Seconds 0 19 N/A N/A Severely Errored Seconds 0 0 N/A N/A Severely Errored Sec Ratio 0 0	Error Ratio		1.704E-02	N/A	N/A	N
G.826 ANALYSIS RS B1 MS B2 MS- PATH H BIP BIP BIP REI BIP Strored Blocks 20 23 64000 7970 Strored Seconds 10 10 10 35 Severely Errored Seconds 6 6 9 10 Aravilable Seconds 0 0 0 0 Path Unavailable Seconds N/A 0 0 0 Severely Errored Sec Ratio 5.825E-02 9.709E-02 1.03IE-01 3.766E-0 Severely Errored Sec Ratio 5.825E-02 5.825E-02 9.278E-02 1.748E-0 Severely Errored Sec Ratio 1.804E-05 2.062E-05 1.420E-06 1.541E-0 Background Block Err Ratio 1.804E-05 2.062E-05 1.420E-06 1.541E-0 Mavailable Seconds 0 0 N/A N/A Severely Errored Seconds 0 19 N/A N/A Severely Errored Seconds 0 N/A N/A N/A Severely Errored Sec Ratio 0 0 N/A <td< td=""><td>Analysis Results :</td><td></td><td></td><td></td><td></td><td></td></td<>	Analysis Results :					
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Dravailable Seconds 0 0 0 Path Unavailable Seconds N/A 0 0 Background Block Errors 14 16 1 1044 Errored Second Ratio 9.709E-02 9.709E-02 1.031E-01 3.786E-0 Beverely Errored Sec Ratio 5.825E-02 5.825E-02 9.278E-02 1.748E-0 Background Block Err Ratio 1.804E-05 2.062E-05 1.420E-06 1.541E-0 Background Block Err Ratio 1.804E-05 2.062E-05 1.420E-06 1.541E-0 Background Block Err Ratio 1.804E-05 2.062E-05 1.420E-06 1.541E-0 Background Block Err Ratio 1.22155 N/A N/A Severely Errored Seconds 0 0 N/A N/A Path Unavailable Seconds 0 N/A N/A N/A Severely Errored Sec Ratio 0 0 N/A N/A Severely Errored Sec Ratio 0 0 N/A N/A Severely Errored Sec 13.59223 N/A N/A N/A	Severely Errored S	leconds	6	6	9	-
N/A 0 0 Background Block Errors 14 16 1 104' Serored Second Ratio 9.709E-02 9.709E-02 1.031E-01 3.786E-02 Severely Errored Sec Ratio 5.825E-02 5.825E-02 9.278E-02 1.420E-06 1.541E-02 Background Block Err Ratio 1.804E-05 2.062E-05 1.420E-06 1.541E-02 Background Block Err Ratio 1.804E-05 2.062E-05 1.420E-06 1.541E-02 Background Block Err Ratio 1.804E-05 2.062E-05 1.420E-06 1.541E-02 Background Block Err Ratio 10 122155 N/A N/A Severely Errored Seconds 0 0 N/A N/A Severely Errored Seconds 0 1/4 N/A N/A Severely Errored Sec Ratio 0 0 N/A N/A Severely Errored Sec Ratio 1.289E-05 1.442E-05 N/A N/A Severely Errored Sec 14 N/A N/A N/A N/A N/A N/A	Jnavailable Second	ls	0	0	0	
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Background Block Err Ratio 1.804E-05 2.062E-05 1.420E-06 1.541E-0 HP- HP- HP- TU LP- REI IEC BIP REI Strored Blocks 10 122155 N/A N/, Strored Seconds 4 3 N/A N/, Severely Errored Seconds 0 19 N/A N/, Severely Errored Seconds 0 N/A N/A N/, Sackground Block Errors 10 9 N/A N/, Severely Errored Seconds 0 N/A N/A N/, Sackground Block Errors 10 9 N/A N/, Severely Errored Sec Ratio 0 0 N/A N/, Sackground Block Err Ratio 1.289E-05 1.442E-05 N/A N/, Gasel AnnaLYSIS BIT (test) FAS 140M FAS 34M FAS 8M FAS 2 Errored Sec 13.59223 N/A N/A N/A N/A Severely E	Severely Errored S	Sec Ratio	5.825E-02	5.825E-02	9.278E-02	1.748E-0
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REIIECBIPREICrrored Blocks10122155N/AN/ASeverely Errored Seconds00N/AN/AGavariable Seconds019N/AN/AMavailable Seconds019N/AN/ASackground Block Errors109N/AN/ASeverely Errored Sec Ratio00N/AN/ASeverely Errored Sec Ratio00N/AN/ASackground Block Err Ratio1.289E-051.442E-05N/AN/ASackground Block Err Ratio1.289E-051.442E-05N/AN/ASeverely Errored Sec14N/AN/AN/AN/ASackground Block Err Ratio1.289E-051.442E-05N/AN/ASeverely Errored Sec1359223N/AN/AN/AN/ASerrored Sec13.59223N/AN/AN/AN/ASeverely Err Sec66.40777N/AN/AN/AN/ASeverely Err Sec13.59223N/AN/AN/AN/ASeverely Err Sec13.59223N/AN/AN/AN/ASeverely Err Sec13.59223N/AN/AN/AN/ASeverely Err Sec13.59223N/AN/AN/AN/ASeverely Err Sec13.59223N/AN/AN/AN/ASeverely Err Sec13.59223N/AN/AN/AN/ASeverely Err Sec13.59223N/AN/AN/A <td></td> <td></td> <td>HP-</td> <td>HP-</td> <td>10</td> <td>LP-</td>			HP-	HP-	10	LP-
Errored Blocks10122155N/AN/AStrored Seconds43N/AN/ASeverely Errored Seconds00N/AN/AJnavailable Seconds019N/AN/ASackground Block Errors109N/AN/ABackground Block Errors109N/AN/ASeverely Errored Sec Ratio00N/AN/ASackground Block Err Ratio1.289E-051.442E-05N/AN/ASackground Sec14N/AN/AN/AN/AStrored Sec13.59223N/AN/AN/AN/ASeverely Err Sec13.59223N/AN/AN/AN/ASeverely Err Sec13.59223N/AN/AN/AN/ASeverely Err Sec13.59223N/AN/AN/AN/ASeperaded Minutes0.00000N/AN/AN/AN/ASeperely Err Sec13.59223N/AN/AN/AN/ASeperely Err Sec13.59223<			REI	IEC	BIP	REI
Errored Seconds43N/AN/ASeverely Errored Seconds00N/AN/ADavailable Seconds019N/AN/APath Unavailable Seconds0N/AN/AN/APath Unavailable Seconds0N/AN/AN/APath Unavailable Seconds0N/AN/AN/APath Unavailable Seconds109N/AN/ABackground Block Errors100N/AN/ASeverely Errored Sec Ratio00N/AN/ABackground Block Err Ratio1.289E-051.442E-05N/AN/ABIT (test)FAS 140MFAS 34MFAS 8MFAS 34Errored Sec13.59223N/AN/AN/AN/AKES (Annex D)6.79612N/AN/AN/AN/AStror Free Sec86.40777N/AN/AN/AN/AKError Free Sec13.59223N/AN/AN/AN/ASeverely Err Sec13.59223N/AN/AN/AN/ASeverely Err Sec13.59223N/AN/AN/AN/ASeverely Err Sec13.59223N/AN/AN/AN/ASeverely Err Sec13.59223N/AN/AN/AN/ASeperaded Minutes0.00000N/AN/AN/AN/ASeperaded Minutes0.00000N/AN/AN/AN/ASeperaded Minutes0.00000N/AN/AN/AN/A<	Grrored Blocks		10	122155	N/A	N,
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Inavailable Seconds019N/AN/APath Unavailable Seconds0N/AN/AN/APath Unavailable Seconds0N/AN/AN/ASackground Block Errors109N/AN/AStrored Second Ratio4.124E-023.846E-02N/AN/ASeverely Errored Sec Ratio00N/AN/ASackground Block Err Ratio1.289E-051.442E-05N/AN/ASackground Block Err Ratio1.289E-051.442E-05N/AN/AG.821 ANALYSISSackerrored Sec14N/AN/AN/AEIT (test)FAS 140MFAS 34MFAS 8MFAS 34Errored Sec13.59223N/AN/AN/AN/AKError Free Sec89N/AN/AN/AN/ASeverely Err Sec14N/AN/AN/AN/ASeverely Err Sec13.59223N/AN/AN/AN/ASeverely Err Sec13.59223N/AN/AN/AN/ASeverely Err Sec13.59223N/AN/AN/AN/ASeverely Err Sec13.59223N/AN/AN/AN/ASeperaded Minutes0.00000N/AN/AN/AN/AKupavailable Sec0N/AN/AN/AN/A	Severely Errored S	econds	0	0	N/A	N,
NA NA<	Unavailable Second	is	0	19	N/A	N,
Background Block Errors 10 9 N/A N, Errored Second Ratio 4.124E-02 3.846E-02 N/A N, Severely Errored Sec Ratio 0 0 N/A N, Background Block Err Ratio 1.289E-05 1.442E-05 N/A N, BIT (test) FAS 140M FAS 34M FAS 8M FAS 34M Errored Sec 14 N/A N/A N, KErrored Sec 13.59223 N/A N/A N, KES (Annex D) 6.79612 N/A N/A N, KError Free Sec 86 N/A N/A N, Kerror Free Sec 86.40777 N/A N/A N, Severely Err Sec 13.59223	Path Unavailable S	econds	0	N/A	N/A	N,
Errored Second Ratio 4.124E-02 3.846E-02 N/A N/A Severely Errored Sec Ratio 0 0 N/A N/A Background Block Err Ratio 1.289E-05 1.442E-05 N/A N/A Background Block Err Ratio 1.289E-05 1.442E-05 N/A N/A G.821 ANALYSIS BIT (test) FAS 140M FAS 34M FAS 8M FAS 3 Errored Sec 14 N/A N/A N/A N/A Strored Sec 13.59223 N/A N/A N/A N/A Stror Free Sec 89 N/A N/A N/A N/A Stror Free Sec 86.40777 N/A N/A N/A N/A Severely Err Sec 14 N/A N/A N/A N/A Severely Err Sec 13.59223 N/A N/A N/A N/A Severely Err Sec 13.59223 N/A N/A N/A N/A Severely Err Sec 13.59223 N/A N/A N/A	Background Block H	rrors	10	9	N/A	N,
Severely Errored Sec Ratio 0 0 N/A N/A Background Block Err Ratio 1.289E-05 1.442E-05 N/A N/A G.821 ANALYSIS G.821 ANALYSIS BIT (test) FAS 140M FAS 34M FAS 8M FAS 34M Errored Sec 14 N/A N/A N/A N/A KErrored Sec 13.59223 N/A N/A N/A N/A Error Free Sec 6.79612 N/A N/A N/A N/A Error Free Sec 86.40777 N/A N/A N/A N/A Severely Err Sec 13.59223 N/A N/A N/A N/A Severely Err Sec 14 N/A N/A N/A N/A N/A Severely Err Sec 13.59223 N/A N/A N/A N/A N/A Seperaded Minutes 0 N/A N/A N/A N/A N/A Mageraded Minutes 0.00000 N/A N/A N/A N/A N/A N/A	Errored Second Rat	io	4.124E-02	3.846E-02	N/A	N,
Background Block Err Ratio $1.289E-05$ $1.442E-05$ N/AN/AG.821 ANALYSISBIT (test)FAS 140MFAS 34MFAS 8MFAS 3BIT (test)FAS 140MFAS 34MFAS 8MFAS 3Errored Sec14N/AN/AN/AN/AKErrored Sec13.59223N/AN/AN/AN/AKES (Annex D) 6.79612 N/AN/AN/AN/AStror Free Sec89N/AN/AN/AN/ASeverely Err Sec14N/AN/AN/AN/ASeverely Err Sec13.59223N/AN/AN/AN/ASeverely Err Sec13.59223N/AN/AN/AN/ASeperaded Minutes0N/AN/AN/AN/AMaratilable Sec0N/AN/AN/AN/AKUnavailable Sec0.00000N/AN/AN/AN/A	Severely Errored S	ec Ratio	0	0	N/A	N,
BIT (test) FAS 140M FAS 34M FAS 8M FAS 3 Errored Sec 14 N/A N/A N/A N/A N/A KErrored Sec 13.59223 N/A N/A N/A N/A N/A Sec 13.59223 N/A N/A N/A N/A N/A Error Free Sec 89 N/A N/A N/A N/A N/A Severely Err Sec 14 N/A N/A N/A N/A N/A Severely Err Sec 13.59223 N/A N/A N/A N/A N/A Segereded Minutes 0 N/A N/A N/A N/A N/A Marvilable Sec 0 N/A N/A N/A N/A N/A KUnavailable Sec 0.00000 N/A N/A N/A N/A N/A	Background Block H	rr Ratio	1.289E-05	1.442E-05	N/A	N,
Bit (0000)Ind <td></td> <td>BTT (test)</td> <td>FAS 140M</td> <td>FAS 34M</td> <td>FAS 8M</td> <td>FAS</td>		BTT (test)	FAS 140M	FAS 34M	FAS 8M	FAS
Arrorad Sec13.59223N/AN/AN/AN/AN/AkErrored Sec13.59223N/AN/AN/AN/AN/AStror Free Sec89N/AN/AN/AN/AStror Free Sec86.40777N/AN/AN/AN/AKError Free Sec86.40777N/AN/AN/AN/ASeverely Err Sec14N/AN/AN/AN/ASeverely Err Sec13.59223N/AN/AN/AN/ADegraded Minutes0N/AN/AN/AN/AJnavailable Sec0N/AN/AN/AN/AKUnavailable Sec0.00000N/AN/AN/AN/A	Errored Sec	14	N/A	M/A	NT/7	TAU A
School Sector 10:39223 N/A N/A N/A N/A N/A MEES (Annex D) 6.79612 N/A N/A N/A N/A N/A Stror Free Sec 89 N/A N/A N/A N/A N/A Stror Free Sec 86.40777 N/A N/A N/A N/A Severely Err Sec 14 N/A N/A N/A N/A Severely Err Sec 13.59223 N/A N/A N/A N/A Obegraded Minutes 0 N/A N/A N/A N/A Inavailable Sec 0 N/A N/A N/A N/A	Frrored Sec	13 59222	N/A	N/A	N/A	N/
Schwarz D, 0.19012 N/A N/A N/A N/A Scror Free Sec 89 N/A N/A N/A N/A Scror Free Sec 86.40777 N/A N/A N/A N/A Severely Err Sec 14 N/A N/A N/A N/A Severely Err Sec 13.59223 N/A N/A N/A N/A Degraded Minutes 0 N/A N/A N/A N/A Inavailable Sec 0 N/A N/A N/A N/A	ET (Anney D)	5 70610	N/A N/A	IN/A M/A	IN/A M/A	N/
School Free Sec op N/A N/A N/A N/A N/A KError Free Sec 86.40777 N/A N/A N/A N/A N/A Severely Err Sec 14 N/A N/A N/A N/A N/A kSeverely Err Sec 13.59223 N/A N/A N/A N/A >begraded Minutes 0 N/A N/A N/A N/A /begraded Minutes 0.00000 N/A N/A N/A N/A /bull Automatical Sec 0 N/A N/A N/A N/A /bull Automatical Sec 0 N/A N/A N/A N/A	ETTON ETTOS COS	0./3012	IN/A	N/A	IN/A	N/
Severely Err Sec 60.40777 N/A N/A N/A N/A N/A Severely Err Sec 14 N/A N/A N/A N/A Severely Err Sec 13.59223 N/A N/A N/A N/A Degraded Minutes 0.00000 N/A N/A N/A N/A N/A Degraded Minutes 0.00000 N/A N/A N/A N/A N/A Jnavailable Sec 0.00000 N/A N/A N/A N/A N/A	Find Line Sec	89	N/A	N/A	N/A	N/
severely Err Sec 14 N/A N/A N/A N/A N/A &Severely Err Sec 13.59223 N/A N/A N/A N/A Degraded Minutes 0.00000 N/A N/A N/A N/A Degraded Minutes 0.00000 N/A N/A N/A N/A Jnavailable Sec 0.00000 N/A N/A N/A N/A	SEITOR Free Sec	86.40777	N/A	N/A	N/A	N/
Kseverely Err Sec 13.59223 N/A	Severely Err Sec	14	N/A	N/A	N/A	N,
Degraded Minutes 0 N/A	Severely Err Sec	13.59223	N/A	N/A	N/A	N/
&Degraded Minutes 0.00000 N/A N/A N/A N/ Jnavailable Sec 0 N/A N/A N/A N/ &Unavailable Sec 0.00000 N/A N/A N/A N/	Degraded Minutes	0	N/A	N/A	N/A	N/
Jnavailable Sec O N/A N/A N/A N/ &Unavailable Sec 0.00000 N/A N/A N/A N/	*Degraded Minutes	0.00000	N/A	N/A	N/A	N/
&Unavailable Sec 0.00000 N/A N/A N/A N/A N/	Unavailable Sec	0	N/A	N/A	N/A	N/
	&Unavailable Sec	0.00000	N/A	N/A	N/A	N/

l				
ĺ	G.826 ANA	LYSIS		
ĺ	Near	140Mb/s Far	Near	34Mb/s Far
Errored Seconds	6	N/A	N/A	N/A
Severely Errored Seconds	6	N/A	N/A	N/A
Unavailable Seconds	0	N/A	N/A	N/A
Errored Second Ratio	5.825E-02	N/A	N/A	N/A
Severely Errored Sec Ratio	5.825E-02	N/A	N/A	N/A
	M.2100 ANA	LYSIS		
İ	Rx	140Mb/s Tx	Rx	34Mb/s Tx
Errored Seconds	14	N/A	N/A	N/A
Severely Errored Seconds	14	N/A	N/A	N/A
Unavailable Seconds	0	N/A	N/A	N/A
	M.2110 ANA	LYSIS		
İ		2-hr	24-hr	7-day
BIS Results		WAIT	WAIT	WAIT
Frequency : N/A Hz	Offset :	N/AHz	Offset :	N/Appm
 Pointer Results :	AU PO	INTER	TU	POINTER
	Count	Seconds	Count	Seconds
NDF		3		N/A
Missing NDF		4		N/A
+ve Pointer Adjustments	3	3	N/A	N/A
-ve Pointer Adjustments	5	4	N/A	N/A
Implied VC Offset	0.0		N/A	
Pointer Value	256		N/A	

Logging At End of Measurement Example

Bar Graph Logging

To log the Bar Graphs:

On the **OTHER LOGGING** display, LOGGING SETUP **DEVICE**, select the required logging device under LOGGING PORT.

On the **OTHER LOGGING** CONTROL display, select LOGGING [ON].

Display the Bar Graphs required on the Bar Graph display and press **PRINT**.

Select THIS SCREEN

The Error Summary, the Alarm Summary, the selected Bar Graphs and the Alarms Graph are logged.



Bar Graph Logging Example

Graphics Text Results Logging

To log the Alarm Summaries:

Select the required logging device under LOGGING PORT on the **OTHER LOGGING** display.

Select LOGGING [ON] on the **OTHER LOGGING** display.

Display the results required on the Text Results display and press **PRINT**.

The Error Summary and Alarm Summary are logged.

Results Snapshot Logging

To log the Results Snapshot:

Select the required External logging device under LOGGING PORT on the **OTHER LOGGING** display.

Select LOGGING [ON] on the **OTHER LOGGING** display.

Select LOG ON DEMAND [RESULTS] on the **OTHER LOGGING** display and press **PRINT NOW**.

======================================										
	Hew	lett Packard	HP37717C							
	Ins	trument Conf	iguration							
RECEIVER	• CTTM_1 F									
I Level	• TERMINA	TE								
Mapping	: AU-4	VC-4	140 Mb/s							
Pavload Type	: UNFRAME	D I	110 110/0							
Pattern	: 2^23-1	-	Polarity	: IN	VERTED					
MEASUREMENT STARTED 23 Jul 97 10:35:59 Print Period 10 Minutes										
10:37:19 PRINT D	DEMANDED- RES	ULTS SNAPSHO	T Elapsed	d Time 00d	00h 01m 20s					
======================================										
		Cumulative R	esults							
 Error Results •										
EITOI Repuits .	A1A2	RS B1	MS B2	MS-	РАТН ВЗ					
i	FRAME	BIP	BIP	REI	BIP					
Error Count	293	81633	261	876107	95					
Error Ratio	9.538E-06	6.561E-06	2.121E-08	7.793E-05	7.899E-09					
İ										
	HP-	HP-	TU	LP-						
	REI	IEC	BIP	REI						
Error Count	23	607484	N/A	N/A						
Error Ratio	1.961E-09	5.181E-05	N/A	N/A						
			CODE	CDC	DEDE					
 Error Count		1 940E+09	CODE N/A		N/A					
Error Batio		1.651E-02	N/A N/A	N/A N/A	N/A N/A					
		1.0512 02	11/11							
Analysis Results	:									
i -		G.826 ANALY	SIS							
		RS B1	MS B2	MS-	PATH B3					
		BIP	BIP	REI	BIP					
Errored Blocks		42284	18	45573	20					
Errored Seconds		19	5	12	5					
Severely Errored	Seconds	9	3	11	3					
Unavailable Secon	nds	0	0	0	0					
Path Unavailable	Seconds	N/A	0	0	0					
Background Block	Errors	643	12	2189	18					
Errorea Second Ra	Cog Patio	2.375E-01 1 125E-01	0.250E-02	1 4208-01	0.250E-02					
Beverery Friored	Frr Datio	1 1228-01	1 0/98-02	1 146E-01	3./30E-02					
Background Block	EII RALIO	1.1326-03	1.9406-05	4.1408-03	2.9226-05					

1				
	HP-	HP-	TU	LP-
	REI	IEC	BIP	REI
Errored Blocks	5	316822	N/A	N/A
Errored Seconds	2	1	N/A	N/A
Severely Errored Seconds	0	0	N/A	N/A
Unavailable Seconds	0	40	N/A	N/A
Path Unavailable Seconds	0	N/A	N/A	N/A
Background Block Errors	5	1426	N/A	N/A
Errored Second Ratio	2.597E-02	2.703E-02	N/A	N/A
Severely Errored Sec Ratio	0	0	N/A	N/A
Background Block Err Ratio	8.117E-06	4.818E-03	N/A	N/A
	C 921 ANTA	VOTO		
PTT (togt)	G.821 ANA	LISIS DIG 3/M	ENC OM	ENG 2M
Frrored Sec	FAS 140M	TAS 54M	FAS OM	FAS ZM N/A
Servered Sec 11 25000	N/A	N/A N/A	N/A	N/A N/A
8ES (Annex D) 5 0000	N/A N/A	N/A N/A	N/A N/A	N/A N/A
Error Free Sec 71	N/A N/A	N/A	N/A	N/A
Servor Free Sec 88.75000	N/A	N/A	N/A	N/A
Severely Err Sec 9	N/A	N/A	N/A	N/A
Severely Err Sec 11,25000	N/A	N/A	N/A	N/A
Degraded Minutes 0	N/A	N/A	N/A	N/A
8Degraded Minutes 0.00000	N/A	N/A	N/A	N/A
Unavailable Sec 0	N/A	N/A	N/A	N/A
%Unavailable Sec 0.00000	N/A	N/A	N/A	N/A
İ				
İ	G.826 ANA	LYSIS		
	Near	140Mb/s Far	Near	34Mb/s Far
Errored Seconds	3	N/A	N/A	N/A
Severely Errored Seconds	3	N/A	N/A	N/A
Unavailable Seconds	0	N/A	N/A	N/A
Errored Second Ratio	3.750E-02	N/A	N/A	N/A
Severely Errored Sec Ratio	3.750E-02	N/A	N/A	N/A
	M.2100 ANAL			
Freenad Cogonda	RX 0	140MD/S 1X	RX N/A	34MD/S IX
Errored Seconds	9	N/A	N/A	N/A
Unavailable Seconds	9	N/A N/A	N/A N/A	N/A N/A
	0	N/A	N/A	N/A
	M.2110 ANA	LYSIS		
		2-hr	24-hr	7-dav
BIS Results		WAIT	WAIT	WAIT
i				
İ				
Frequency : 155520000 Hz	Offset :	+0Hz	Offset :	+0.0ppm
Pointer Results :	AU PO:	INTER	TU	POINTER
	Count	Seconds	Count	Seconds
		3		N/A
Missing NDF	2	2	NT / -	N/A
+ve Pointer Adjustments	3	3	N/A	N/A
-ve Fointer Adjustments	L	T	N/A	N/A
Implied VC UIISET	-0.0		N/A	
I FOILLEE VALUE	512		N/A	

Results Snapshot Logging Example

Overhead Capture Logging

To log the Overhead Capture:

Select the required External logging device under LOGGING PORT on the **OTHER LOGGING** display.

Select LOGGING [ON] on the **OTHER LOGGING** display.

Select LOG ON DEMAND [O/H CAPTURE] on the **OTHER LOGGING** display and press **PRINT NOW**.

=====================================	CAPTURE Elapsed Time 00d 00h 00m 02s
Setup : SIM-le Capture of channel [3xA1, 3xA2] Trigger OFF
DATA	FRAME COUNT
F6F6F6282828	64000
F6F6F6282828	64000
F6F6F6282828	40041
B626D6289828	1002
F6F6F6282828	64000
3636C4F82828	10
B626D6289828	1002
F6F6F6282828	64000

Overhead Capture Logging Example

Overhead Snapshot Logging

To log the Overhead Snapshot:

Select the required External logging device under LOGGING PORT on the **OTHER LOGGING** display.

Select LOGGING [ON] on the **OTHER LOGGING** display.

Select LOG ON DEMAND [O/H SNAPSHOT] on the **OTHER LOGGING** display and press **PRINT NOW**.

=====																
10:4	41:45	PR	INT	DEMANI	DED-	0/Н	SNAP	SHOT		E	laps	ed Time	00d	00h	01m	44s
=====			====			====				====						
!	I	Set	up :	STM-1	Le											
	 ਤ੦ਸ											 I				
	+			+	+			+	+			+				
A1	F 6	F6	F6	A2	28	28	28	J0	01	AA	AA	J0 Path	Trac	:e:		
B1	5E	00	00	E1	00	00	00	F1	00	00	00					
D1	00	00	00	D2	00	00	00	D3	00	00	00	İ				
H1	6A	93	93	Н2	00	FF	FF	Н3	00	00	00	S1 Sync	Stat	us:		
B2	AA	в8	97	K1	00	00	00	K2	00	00	00	G.811				
D4	00	00	00	D5	00	00	00	D6	00	00	00					
D7	00	00	00	D8	00	00	00	D9	00	00	00					
D10	00	00	00	D11	00	00	00	D12	00	00	00					
S1	02	00	00	M1	00	00	00	E2	00	00	00					
+	+ ~h~	dor		+	+		4	++	+ * 0rd			+				
	JII OL +							++	+			11FE N				
1	İ	C2	Sig	nal La	abel:			i i								
J1	48		ASYN	C 1401	1			i i								
В3	EA							i	İ							
C2	12	J1	Pat	h Trac	:e:			İ								
G1	00		"HP:	- GB00	0007	15"		1								
F2	00															
H4	00															
F3	00															
К3	00															
N1	00															
=====		====	====	=====		====				====	====		=====			

Overhead Snapshot Logging Example

SDH Tributary Scan Logging

To log the SDH Tributary Scan:

Select the required External logging device under LOGGING PORT on the **OTHER LOGGING** display.

Select LOGGING [ON] on the **OTHER LOGGING** display.

Select LOG ON DEMAND [TRIB SCAN] on the **OTHER LOGGING** display and press **PRINT NOW**.

======= 11:20:2	11:20:26 PRINT DEMANDED- TRIBUTARY SCAN Elapsed Time 00d 00h 00m 10s									
======= RECEIV MAPPIN TEST T ERROR	RECEIVE SIGNAL : STM-1 MAPPING : AU-4 TEST TIME : 10 SECS ERROR THRESHOLD : > 0									
	TUG-3 #1									
TU-12	TUG-2 #1	TUG-2 #2	TUG-2 #3	TUG-2 #4	TUG-2 #5	TUG-2 #6	TUG-2 #7			
	#1 PASS #2 PASS #3 PASS	#1 PASS #1 PASS #1 PASS #1 PASS #1 PASS #2 PASS #2 PASS #2 PASS #2 PASS #2 PASS #3 PASS #3 PASS #3 PASS #3 PASS #3 PASS								
		τυ	4 G-3 #2	+	+	+	+			
	TUG-2 #1	TUG-2 #2	TUG-2 #3	 TUG-2 #4	+ TUG-2 #5	+ TUG-2 #6	TUG-2 #7			
	#1 PASS #2 PASS #3 PASS	#1 PASS #2 PASS #3 PASS	#1 PASS #2 PASS #3 PASS	#1 PASS #2 PASS #3 PASS	#1 PASS #2 PASS #3 PASS	#1 PASS #2 PASS #3 PASS	#1 PASS #2 PASS #3 PASS			
		τυ	+ G-3 #3	+	+	+	+			
	TUG-2 #1	TUG-2 #2	TUG-2 #3	TUG-2 #4	 TUG-2 #5	 TUG-2 #6	TUG-2 #7			
 	#1 PASS #2 PASS #3 PASS	#1 PASS #2 PASS #3 PASS	#1 PASS #2 PASS #3 PASS	#1 PASS #2 PASS #3 PASS	#1 PASS #2 PASS #3 PASS	#1 PASS #2 PASS #3 PASS	#1 PASS #2 PASS #3 PASS			

SDH Tributary Scan Logging Example

Pointer Graph Logging

To log thePointer Graph:

Select the required External logging device under LOGGING PORT on the **OTHER LOGGING** display.

Select LOGGING [ON] on the **OTHER LOGGING** display.

Select LOG ON DEMAND [PTR GRAPH] on the **OTHER LOGGING** display and press **PRINT NOW**].

=========											
11:31:10	6 PR	INT DE	EMANDED-	POINT	ER GRA	APH	Elap	sed Ti	ime 00d 0	0h 01	m 22s
========		=====		=====	=====					=====	=====
CAPTURE	INTE	RVAL	: 1 S	econd							
POINTER	UNDE	R TESI	r : AU-	4							
	+	+	+	+	+	+	+	++		+	+
Period	MAX	MIN	Period	MAX	MIN	Period	MAX	MIN	Period	MAX	MIN
	+	++	+	+	+	+	+	+		+	+
1	0	-18	73	UR	UR	145	NR	NR	217	NR	NR
2			74		UR		INR	NR	218	INR	NR
			75 76			147 140	INR	NR	219		INR
1 4			70 77			140	INR	NR.	220	INR	
			// 79			1 150		IND	221		
1 7			78 79			150 151	INR	NR	222	INR	INRI
8			80			152	NR	NR	224	NR	NR I
9			81			153	NR	NR	225	NR	INR
10	UR	UR	82	UR	UR	154	NR	NR	226	NR	NR
1 11	UR	UR	83	NR	NR	155	NR	NR	227	NR	NR
12	UR	UR	84	NR	NR	156	NR	NR	228	NR	NR
13	UR	UR	85	NR	NR	157	NR	NR	229	NR	NR
14	UR	UR	86	NR	NR	158	NR	NR	230	NR	NR
15	UR	UR	87	NR	NR	159	NR	NR	231	NR	NR
16	UR	UR	88	NR	NR	160	NR	NR	232	NR	NR
17	UR	UR	89	NR	NR	161	NR	NR	233	NR	NR
18	UR	UR	90	NR	NR	162	NR	NR	234	NR	NR
19	UR	UR	91	NR	NR	163	NR	NR	235	NR	NR
20	UR	UR	92	NR	NR	164	NR	NR	236	NR	NR
21	UR	UR	93	NR	NR	165	NR	NR	237	NR	NR
22	UR	UR	94	NR	NR	166	NR	NR	238	NR	NR
23	UR	UR	95	NR	NR	167	NR	NR	239	NR	NR
24	UR	UR	96	NR	NR	168	NR	NR	240	NR	NR
25	UR	UR	97	NR	NR	169	NR	NR	241	NR	NR
26	UR	UR	98	NR	NR	170	NR	NR	242	NR	NR
27	UR	UR	99	NR	NR	171	NR	NR	243	NR	NR
28	UR	UR	100	NR	NR	172	NR	NR	244	NR	NR
29				INR	NR	1 173	INR	NR	245	NR	NR
30 31			LU2		INR	174 175	INR	INR	246	INR	NR
3⊥ 3∩			L T03		INR	175 176			247	INR	INR
32 33			104 105		INR	⊥/6 177	INR	INK	248	INR	INK
31			105	NIC	NR	17º	INR	ND	249	ND	I NR
35			107		ND	⊥/0 170	I NTD	ND	250	ND	
35			109	INR	NR	180	INR	NR	251	NR	NR
37			109	NR	NR	181	NR	NR	253	NR	NR I
38			110	NR	NR	182	NR	NR	253	NR	NR
39		UR	111	NR	NR	183	NR	NR	255	NR	NR
											1

40	UR	UR	112	NR	NR	184	NR	NR	256	NR	NR
41	UR	UR	113	NR	NR	185	NR	NR	257	NR	NR
42	UR	UR	114	NR	NR	186	NR	NR	258	NR	NR
43	UR	UR	115	NR	NR	187	NR	NR	259	NR	NR
44	UR	UR	116	NR	NR	188	NR	NR	260	NR	NR
45	UR	UR	117	NR	NR	189	NR	NR	261	NR	NR
46	UR	UR	118	NR	NR	190	NR	NR	262	NR	NR
47	UR	UR	119	NR	NR	191	NR	NR	263	NR	NR
48	UR	UR	120	NR	NR	192	NR	NR	264	NR	NR
49	UR	UR	121	NR	NR	193	NR	NR	265	NR	NR
50	UR	UR	122	NR	NR	194	NR	NR	266	NR	NR
51	UR	UR	123	NR	NR	195	NR	NR	267	NR	NR
52	UR	UR	124	NR	NR	196	NR	NR	268	NR	NR
53	UR	UR	125	NR	NR	197	NR	NR	269	NR	NR
54	UR	UR	126	NR	NR	198	NR	NR	270	NR	NR
55	UR	UR	127	NR	NR	199	NR	NR	271	NR	NR
56	UR	UR	128	NR	NR	200	NR	NR	272	NR	NR
57	UR	UR	129	NR	NR	201	NR	NR	273	NR	NR
58	UR	UR	130	NR	NR	202	NR	NR	274	NR	NR
59	UR	UR	131	NR	NR	203	NR	NR	275	NR	NR
60	UR	UR	132	NR	NR	204	NR	NR	276	NR	NR
61	UR	UR	133	NR	NR	205	NR	NR	277	NR	NR
62	UR	UR	134	NR	NR	206	NR	NR	278	NR	NR
63	UR	UR	135	NR	NR	207	NR	NR	279	NR	NR
64	UR	UR	136	NR	NR	208	NR	NR	280	NR	NR
65	UR	UR	137	NR	NR	209	NR	NR	281	NR	NR
66	UR	UR	138	NR	NR	210	NR	NR	282	NR	NR
67	UR	UR	139	NR	NR	211	NR	NR	283	NR	NR
68	UR	UR	140	NR	NR	212	NR	NR	284	NR	NR
69	UR	UR	141	NR	NR	213	NR	NR	285	NR	NR
70	UR	UR	142	NR	NR	214	NR	NR	286	NR	NR
71	UR	UR	143	NR	NR	215	NR	NR	287	NR	NR
72	UR	UR	144	NR	NR	216	NR	NR	288	NR	NR
				=====			=====				=====

Pointer Graph Logging Example

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SDH Self Test Error Codes

When self test is run fail numbers may be displayed. The fail numbers and a description are listed below.

Table 5-3Processor Self Test

No.	Description	No.	Description
1020	SRAM Error	1021	SRAM Error
1022	SRAM Error	1023	SRAM Error
1024	SRAM Adress Error	1040	RS232 DCD
1041	RS232 R1	1042	RS232 DSR
1043	RS232 CTS	1044	RS232 Rx too many bytes
1045	RS232 Tx time out	1046	RS232 Rx too few bytes
1047	RS232 Tx/Rx Data t	1052	HP-IB Driver Chip
1060	Real Time Clock Set Incorrectly	1061	Real Time Clock Not Ticking correctly
1070	Parallel Port No Send Data	1080	Internal Printer
1081	Keyboard Processor Internal RAM	1082	Keyboard Processor External RAM
1083	Keyboard Processor ROM	1084	Front Panel No Response
1085	Front Panel Bad Command	1086	Front Panel Invalid Error Returned
1087	Front Panel CPU or UART	1088	Cannot Detect Front Panel Printer
1090	VRAM Data Error	1100	No Disk in Drive
1101	Disk Full	1102	Disk Write Fail
1103	Disk Read Fail	1104	Disk Verify Read/Write Fail
1110	LAN Failed Power-On Test	1111	LAN Returned Invalid Error Number
1112	LAN Hardware Not Found	1113	Lan Fitted No Test Result
1120	Front Panel No Response	1121	Front Panel Bad Command
1122	Front Panel Returned Invalid Error Number	1123	Dual Port SRAM Data Error
1124	Dual Port SRAM Address Error	1130	Front Panel No Response
1131	Front Panel Bad Command	1132	Front Panel Returned Invalid Error Number
1133	Front Panel FEPROM Sum-check Error	1140	Front Panel No Response
1141	Front Panel Bad Command	1142	Front Panel Returned Invalid Error Number
1143	Front Panel SRAM Data Error	1144	Front Panel SRAM Address Error
1145	Front Panel Address Range Invalid	1150	Front Panel No Response
1151	Front Panel Bad Command	1152	Front Panel Returned Invalid Error Number
1153	Front Panel VRAM Data Error	1154	Front Panel Stored Fonts Corrupted

Table 5-3Processor Self Test

No.	Description	No.	Description
1155	Front Panel Address Range Invalid	1156	Front Panel VGA Controller Error
1160	Front Panel No Response	1161	Front Panel Bad Command
1162	Front Panel Returned Invalid Error Number	1163	Front Panel UART Tx/Rx Error Internal
1164	Front Panel Internal Loopback not Reset	1166	Front Panel UART Tx/Rx Error External

Table 5-4 SDH Tests Option A3R (STM-1)

No.	Description	No.	Description
721	Sync Loss	724	Bit Errors
731	Monitor, False Sync	741	Rx loss of Signal

Table 5-5 SDH Tests Option A3R (STM-1, Overhead)

No.	Description	No.	Description
7101	Overhead processor failed	7102	Path Overhead fail
7104	section Overhead fail	7111	VC4 J1 fail
7121	B1 Error Add, Sync Loss	7123	B1 Errors, Result Low
7124	B1 Errors, Result High	7131	B2 Error Add, Sync Loss
7133	B2 Errors, Result Low	7134	B2 Errors, Result High
7141	B3 Error Add, Sync Loss	7143	B3 Errors, Result Low
7144	B3 Errors, Result High	7151	MS-REI Error Add, Sync Loss
7153	MS-REIE Errors, Result Low	7154	RS-REI Errors, Result High
7161	PIEC Error Add, Sync Loss	7163	PIEC Errors, Result Low
7164	PIEC Errors, Result High		
7171	Error Add Off - Loss of Frame	7172	Error Add 1 in 4 - Loss of Frame

Table 5-5 SDH Tests Option A3R (STM-1, Overhead)

No.	Description	No.	Description
7173	Error Add 2 in 4 - Loss of Frame	7174	Error Add 3 in 4 - Loss of Frame
7175	Error Add 4 in 4 - Frame Sync	7176	Error Add 3 in 4 - Frame Sync
7177	Error Add 2 in 4 - Loss of Frame	7178	Error Add 1 in 4 - Loss of Frame
7179	Error Add Off - Loss of Frame		

Table 5-6 SDH Tests Option A3R (140 Mb/s Payload)

No.	Description	No.	Description
7181	Bit Errors - Sync Loss	7183	Bit Errors - Result Low
7184	Bit Errors - Result High	7191	Error Add 1E3, Offset +100 ppm - Sync Loss
7193	Error Add 1E3, Offset +100 ppm - Result Low	7194	Error Add 1E3, Offset +100 ppm - Result High
7201	Error Add 1E3, Offset -100 ppm - Sync Loss	7203	Error Add 1E3, Offset -100 ppm - Result Low
7204	Error Add 1E3, Offset -100 ppm - Result High		

Table 5-7

SDH Tests Option A3R (TU3 Payload)

No.	Description	No.	Description
7211	VC3 J1 Fail	7221	VC3 B3 Single Error - Sync Loss
7223	VC3 B3 Single Error - Result Low	7224	VC3 B3 Single Error - Result High
7231	VC3 REI Single Error - Sync Loss	7233	VC3 REI Single Error - Result Low
7234	VC3 REI Single Error - Result High	7241	Payload Bit Single Error - Sync Loss
7243	Payload Bit Single Error - Result Low	7244	Payload Bit Single Error - Result High
7251	Background Pattern - RX False Sync	7261	Background Pattern - TUG 1 Pattern Loss
7262	Background Pattern - TUG 3 Pattern Loss		
Table 5-8
 SDH Tests Option A3R (TU12 Payload Overhead)

No.	Description	No.	Description
7271	Async - A1,A2 Sync Loss	7284	Async - B1 Errors
7294	Async - B2 errors	7304	Async - B3 Errors
7314	Async - REI Errors	7324	Async - V5 BIP2 Errors
7334	Async - V5 REI Errors	7341	Floating Byte - A1,A2 Sync Loss
7354	Floating Byte - B1 Errors	7364	Floating Byte - B2 Errors
7374	Floating Byte - B3 Errors	7384	Floating Byte - REI Errors
7394	Floating Byte - V5 BIP2 Errors	7404	Floating Byte - V5 BIP2 Errors
7411	Async V5 BIP2 Add - Sync Loss	7413	Async V5 BIP2 Add - Result Low
7414	Async V5 BIP2 Add - Result High	7421	Async V5 REI Add - Sync Loss
7423	Async V5 REI Add - Result Low	7424	Async V5 REI Add - Result High
7431	Async Payload Bit Add - Sync Loss	7433	Async Payload Bit Add - Result Low
7434	Async Payload Bit Add - Result High	7441	Floating Byte Payload Bit Add - Sync Loss
7433	Floating Byte Payload Bit Add - Result Low	7434	Floating Byte Payload Bit Add - Result High

Table 5-9

SDH Tests Option A3R (Payload Pattern)

No.	Description	No.	Description
7451	140 Mb/s, PRBS23 - Sync Loss	7453	140 Mb/s, PRBS23 - Result Low
7454	140 Mb/s, PRBS23 - Result High	7461	TU3, PRBS15 - Sync Loss
7463	TU3, PRBS15 - Result Low	7464	TU3, PRBS15 - Result High
7471	TU12, WORD - Sync Loss	7473	TU12, WORD - Result Low
7474	TU12, WORD - Result High	7481	TU2, PRBS9 - Sync Loss
7483	TU2, PRBS9 - Result Low	7484	TU2, PRBS9 - Result High
7491	Background PRBS9 - False Pattern Sync TUG1	7501	Background PRBS9 - False Pattern Sync TUG2

Table 5-10 SDH Tests Option A3R (TU12 Payload Bit Error Add)

No.	Description	No.	Description
7511	Sync Loss	7513	Result Low
7514	Result High		

Table 5-11 SDH Tests Option A3R (Freq Offset/Pointer Movements)

No.	Description	No.	Description
7521	140 Mb/s, A1,A2 - Sync Loss	7531	140 Mb/s, H1,H2 - Loss of Pointer
7544	140 Mb/s, B1 - Errors	7554	140 Mb/s, B2 - Errors
7564	140 Mb/s, B3 - Errors	7573	140 Mb/s, +100 ppm - Implied VC Offset Low
7574	140 Mb/s, +100 ppm - Implied VC Offset High	7583	140 Mb/s, -100 ppm - Implied VC Offset Low
7584	140 Mb/s, -100 ppm - Implied VC Offset High	7591	TU3, A1,A2 - Sync Loss
7601	TU3, H1,H2 - Loss of Pointer	7614	TU3, B1 - Errors
7624	TU3, B2 - Errors	7634	TU3, B3 - Errors
7644	TU3, TU BIP - Errors	7653	TU3, +100 ppm - Implied VC Offset Low
7654	TU3, +100 ppm - Implied VC Offset High	7663	TU3, -100 ppm - Implied VC Offset Low
7664	TU3, -100 ppm - Implied VC Offset High	7671	TU12, A1,A2 - Sync Loss
7681	TU12, H1,H2 - Loss of Pointer	7694	TU12, B1 - Errors
7704	TU12, B2 - Errors	7714	TU12, B3 - Errors
7724	TU12, TU BIP - Errors	7733	TU12, +100 ppm - Implied VC Offset Low
7734	TU12, +100 ppm - Implied VC Offset High	7743	TU12, -100 ppm - Implied VC Offset Low
7744	TU12, -100 ppm - Implied VC Offset High		

Table 5-12 SDH Tests Option A3R (Thru Mode and DCC)

No. I	Description	No.	Description
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Table 5-12 SDH Tests Option A3R (Thru Mode and DCC)

7751	Thru Mode - H4 Frame Sync Loss	7761	RS DCC Loopback Fail
7771	MS DCC Loopback Fail		

Table 5-13 SDH Tests Option A3R (Bulk Filled Payload Pattern)

No.	Description	No.	Description
7781	AU-4 Bulk - False Sync	7782	AU-4 Bulk - Sync Loss
7791	TU-3 Bulk - False Sync	7792	TU-3 Bulk - Sync Loss
7801	TU-12 Bulk - False Sync	7802	TU-12 Bulk - Sync Loss

Table 5-14 SDH Tests Option A3R (DS3/DS1 Framing)

No.	Description	No.	Description
7811	DS3 Unframed - False Sync	7812	DS3 Unframed - Sync Loss
7821	DS3 M23 - False Sync	7822	DS3 M23 - Sync Loss
7831	DS3 C-Bit - False Sync	7832	DS3 C-Bit - Sync Loss
7841	DS1 Unframed - False Sync	7842	DS1 Unframed - Sync Loss
7851	DS1 D4 - False Sync	7852	DS1 D4 - Sync Loss
7861	DS1 ESF - False Sync	7862	DS1 ESF - Sync Loss
7871	DS1 SLC-96 - False Sync	7872	DS1 SLC-96 - Sync Loss

Table 5-15 SDH Tests Option A3R (STM-1 J0 Message)

No.	Description	No.	Description
7881	No Errors		

Table 5-16	SDH Tests Op	tion A3R (Pa	yload Patterns)
		· · · ·	

No.	Description	No.	Description
7891	C-4 Bulk, PRBS11 - Sync Loss	7893	C-4 Bulk, PRBS11 - Result Low
7894	C-4 Bulk, PRBS11 - Result High	7901	C-3 Bulk, PRBS9 - Sync Loss
7903	C-3 Bulk, PRBS9 - Result Low	7904	C-3 Bulk, PRBS9 - Result High
7911	C-12 Bulk, Word - Sync Loss	7913	C-12 Bulk, Word - Result Low
7914	C-12 Bulk, Word - Result High	7921	DS3 Unframed PRBS20 - Sync Loss
7923	DS3 Unframed PRBS20 - Result Low	7924	DS3 Unframed PRBS20 - Result High
7931	DS1 Unframed QRSS - Sync Loss	7933	DS1 Unframed QRSS - Result Low
7934	DS1 Unframed QRSS - Result High		

 Table 5-17
 SDH Tests Option A3R (Mixed Payloads)

No.	Description	No.	Description
7945	TUG3 No 2,TU-3 Mapping - TU AIS Alarm	7946	TUG3 No 2,TU-3 Mapping - LP-RDIF Alarm
7947	TUG3 No 2,TU-3 Mapping - TU LOP Alarm	7951	TUG3 No 1,TU-3 Mapping - Sync Loss
7961	TUG3 No 3,TU-3 Mapping - Sync Loss	7975	TUG3 No 1,TU-12Mapping - TU AIS Alarm
7976	TUG3 No 1,TU-12Mapping - LP-RDI Alarm	7977	TUG3 No 1,TU-12Mapping - TU LOP Alarm
7981	TUG3 No 2, TU-12 Mapping - Sync Loss	7991	TUG3 No 3,TU-12Mapping - Sync Loss

 Table 5-18
 SDH Tests Option A3R (TU-12 Background Pattern)

No.	Description	No.	Description
22001	Unframed, PRBS9 - F/G Pattern Loss	22002	D4, PRBS9 - B/G Pattern Loss
22011	ESF, PRBS15 - F/G Pattern Loss	22012	D4, PRBS15- B/G Pattern Loss

Table 5-19 SDH Tests Option A3R (Service Disruption Test)

No.	Description	No.	Description
22021	Sync Loss	22025	Shortest Burst Error
22026	Longest Burst Error	22027	Last Burst Error
22035	Shortest Burst Error	22036	Longest Burst Error
22037	Last Burst Error	22045	Shortest Burst Error
22046	Longest Burst Error	22047	Last Burst Error

Table 5-20SDH Tests Option A3R (STM-0)

No.	Description	No.	Description
22051	STM-0 Loopback - Signal Present	22061	STM-0 Loopback - Sync Loss
22064	STM-0 Loopback - Result High	22071	STM-0 Loopback - False Signal Present
22081	Pulse Shape HI - Sync Loss	22084	Pulse Shape HI - Result High
22091	Pulse Shape LO - Sync Loss	22094	Pulse Shape LO - Result High
22101	Pulse Shape XCONNECT - Sync Loss	22104	Pulse Shape XCONNECT - Result High
22111	Frequency Measurement - Signal Loss	22113	Frequency Measurement - Sync Loss
22114	Frequency Measurement - Result High	22121	C-3 Bulk Framing - False Sync
22122	C-3 Bulk Framing - Sync Loss	22131	TU-2 Bulk Framing - False Sync
22132	TU-12 Bulk Framing - Sync Loss	22141	DS1 Unframed - False Sync
22142	DS1 Unframed - Sync Loss	22151	B1 Error Add - Sync Loss
22153	B1 Error Add - Result Low	22154	B1 Error Add - Result High
22161	B2 Error Add - Sync Loss	22163	B2 Error Add - Result Low
22164	B2 Error Add - Result High	22171	B3 Error Add - Sync Loss
22173	B3 Error Add - Result Low	22174	B3 Error Add - Result High
22181	MS-REI Error Add - Sync Loss	22183	MS-REI Error Add - Result Low
22184	MS -REI Error Add - Result High	22191	IEC Error Add - Sync Loss
22193	IEC Error Add - Result Low	22194	IEC Error Add - Result High
22201	34 Mb/s Mapping, Offset +100ppm - Sync Loss	22203	34 Mb/s Mapping, Offset +100ppm - Result Low
22204	34 Mb/s Mapping, Offset +100ppm - Result High	22211	34 Mb/s Mapping, Offset -100ppm - Sync Loss
22213	34 Mb/s Mapping, Offset -100ppm - Result Low	22214	34 Mb/s Mapping, Offset -100ppm - Result High
22221	DS3 Mapping, Offset +100ppm - Sync Loss	22223	DS3 Mapping, Offset +100ppm - Result Low

SDH

Table 5-20SDH Tests Option A3R (STM-0)

No.	Description	No.	Description
22224	DS3 Mapping, Offset +100ppm - Result High	22231	DS3 Mapping, Offset -100ppm - Sync Loss
22233	DS3 Mapping, Offset -100ppm- Result Low	22234	DS3 Mapping, Offset +100ppm - Result High
22241	THRU Mode Fail		

 Table 5-21
 SDH Tests (Round Trip Delay)

8911	STM-1, 140 Mb/s, 1µs- Pattern Loss	8913	STM-1, 140 Mb/s, 1µs - Result Low
8914	STM-1, 140 Mb/s, 1μs - Result High	8921	STM-1, 140 Mb/s, 2s - Pattern Loss
8923	STM-1, 140 Mb/s, 2s - Result Low	8924	STM-1, 140 Mb/s, 2s - Result High
8931	STM-1, 34 Mb/s, 1µs - Pattern Loss	8933	STM-1, 34 Mb/s, 1µs - Result Low
8934	STM-1, 34 Mb/s, 1µs - Result High	8941	STM-1, 34 Mb/s, 2s - Pattern Loss
8943	STM-1, 34 Mb/s, 2s - Result Low	8944	STM-1, 34 Mb/s, 2s - Result High
8951	STM-1, 2 Mb/s, 1µs - Pattern Loss	8953	STM-1, 2 Mb/s, 1µs - Result Low
8954	STM-1, 2 Mb/s, 1µs - Result High	8961	STM-1, 2 Mb/s, 2s - Pattern Loss
8963	STM-1, 2 Mb/s, 2s - Result Low	8964	STM-1, 2 Mb/s, 2s - Result High

Table 5-22Error Add Tests Options 130, 131

No.	Description	No.	Description
10011	1310 nm STM-1 Pattern Sync Loss	10012	1310 nm STM-1 Signal Loss
10015	1550 nm STM-1 Pattern Sync Loss	10016	1550 nm STM-1 Signal Loss
10022	1310 nm STM-1 - Alarms Present	10026	1550 nm STM-1 - Alarms Present
10031	1310 nm STM-1, Error Add - Pattern Sync Loss	10033	1310 nm STM-1, Error Add - Bit Error Rate Low
10034	1310 nm STM-1, Error Add - Bit Error Rate High	10035	1550 nm STM-1, Error Add - Pattern Sync Loss

Table 5-22Error Add Tests Options 130, 131

No.	Description	No.	Description
10037	1550 nm STM-1, Error Add - Bit Error Rate Low	10038	1550 nm STM-1, Error Add - Bit Error Rate High
10041	1310 nm TX OFF - No Alarms	10042	1310 nm TX OFF - No Signal Loss
10045	1550 nm TX OFF - No Alarms	10046	1550 nm TX OFF - No Signal Loss
10051	1310 nm STM-1 - Failed Frame Sync	10055	1550 nm STM-1 - Failed Frame Sync
10061	1310 nm STM-1 - Frame Alarm (LOF or OOF)	10065	1550 nm STM-1 - Frame Alarm (LOF or OOF)
10071	1310 nm STM-1 #1 - Alarms Present	10072	1310 nm STM-1 #1 - Signal Loss
10075	1550 nm STM-1 #1 - Alarms Present	10076	1550 nm STM-1 #1 - Signal Loss
10081	1310 nm STM-1 #1, Error Add - Pattern Sync Loss	10083	1310 nm STM-1 #1, Error Add - Bit Error Rate Low
10084	1310 nm STM-1 #1, Error Add - Bit Error Rate High	10085	1550 nm STM-1 #1, Error Add - Pattern Sync Loss
10087	1550 nm STM-1 #1, Error Add - Bit Error Rate Low	10088	1550 nm STM-1 #1, Error Add - Bit Error Rate High
10091	1310 nm STM-1 #1 - TX OFF - No Alarms	10092	1310 nm STM-1 # - TX OFF - No Signal Loss
10095	1550 nm STM-1 #1 - TX OFF - No Alarms	10096	1550 nm STM-1 #1 - TX OFF - No Signal Loss
10101	1310 nm STM-1 #2 - Alarms Present	10102	1310 nm STM-1 #2 - Signal Loss
10111	1310 nm STM-1 #2, Error Add - Pattern Sync Loss	10113	1310 nm STM-1 #2, Error Add - Bit Error Rate Low
10114	1310 nm STM-1 #2, Error Add - Bit Error Rate High	10121	1310 nm STM-1 #2 - TX OFF - No Alarms
10122	1310 nm STM-1 #2 - TX OFF - No Signal Loss	10131	1310 nm STM-1 #3 - Alarms Present
10132	1310 nm STM-1 #3 - Signal Loss	10141	1310 nm STM-1 #3, Error Add - Pattern Sync Loss
10143	1310 nm STM-1 #3, Error Add - Bit Error Rate Low	10144	1310 nm STM-1 #3, Error Add - Bit ErrorRate High
10151	1310 nm STM-1 #3 - TX OFF - No Alarms	10152	1310 nm STM-1 #3 - TX OFF - No Signal Loss
10161	1310 nm STM-1 #4 - Alarms Present	10162	1310 nm STM-1 #4 - Signal Loss
10171	1310 nm STM-1 #4, Error Add - Pattern Sync Loss	10173	1310 nm STM-1 #4, Error Add - Bit Error Rate Low
10174	1310 nm STM-1 #4, Error Add - Bit Error Rate High	10181	1310 nm STM-1 #4 - TX OFF - No Alarms
10182	1310 nm STM-1 #4 - TX OFF - No Signal Loss	10191	1310 nm STM-4 - Failed Frame Sync
10192	1310 nm STM-4 - B1 Errors	10195	1550 nm STM-4 - Failed Frame Sync
10196	1550 nm STM-4 - B1 Errors	10202	1310 nm STM-4 - B2 Errors

Table 5-22	Error Add Tests Options	130. 131

No.	Description	No.	Description
10206	1550 nm STM-4 - B2 Errors	10211	1310 nm STM-4, B2 Error Add - Frame Alarm (OOF or LOF)
10213	1310 nm STM-4, B2 Error Add - Bit Error Rate Low	10214	1310 nm STM-4, B2 Error Add - Bit ErrorRate High

Table 5-23Clock Recovery Tests Options 130, 131

No.	Description	No.	Description
10221	STM-4, STM-1 #1 LOF, OOF or LOP	10222	STM-4, STM-1 #1 Signal Loss
10225	STM-4, STM-1 #1 LOF, OOF or LOP	10226	STM-4, STM-1 #1 Signal Loss
10231	STM-4 Clock Recovery LOF, OOF or LOP	10235	STM-4 Clock Recovery LOF, OOF or LOP
10241	STM-4 Clock Recovery LOF, OOF or LOP	10245	STM-4 Clock Recovery LOF, OOF or LOP
10251	STM-4 Clock Recovery LOF, OOF or LOP	10255	STM-4 Clock Recovery LOF, OOF or LOP

Table 5-24

Overhead Tests Options 130, 131

No.	Description	No.	Description
10261	STM-4 Overhead Pattern 1 - Fail to Sync	10262	STM-4 Overhead Pattern 1 - Pattern Error
10271	STM-4 Overhead Pattern 1 - Fail to Sync	10272	STM-4 Overhead Pattern 1 - Pattern Error
10281	STM-1 Overhead Pattern 1, Columns 1,4,7 - Fail to Sync	10282	STM-1 Overhead Pattern 1, Columns1,4,7 - Pattern Error
10291	STM-1 Overhead Pattern 1, Columns 2,5,8 - Fail to Sync	10292	STM-1 Overhead Pattern 1, Columns2,5,8 - Pattern Error
10301	STM-1 Overhead Pattern 1, Columns 3,6,9 - Fail to Sync	10302	STM-1 Overhead Pattern 1, Columns3,6,9 - Pattern Error
10311	STM-1 Overhead Pattern 2, Columns 1,4,7 - Fail to Sync	10312	STM-1 Overhead Pattern 2, Columns1,4,7 - Pattern Error
10321	STM-1 Overhead Pattern 2, Columns 2,5,8 - Fail to Sync	10322	STM-1 Overhead Pattern 2, Columns2,5,8 - Pattern Error

Table 5-24Overhead Tests Options 130, 131

No.	Description	No.	Description
10331	STM-1 Overhead Pattern 2, Columns 3,6,9 - Fail to Sync	10332	STM-1 Overhead Pattern 2, Columns3,6,9 - Pattern Error
10341	STM-1 #1 Overhead Pattern 1, Columns 1,4,7 - Fail to Sync	10342	STM-1 #1 Overhead Pattern 1,Columns 1,4,7 - Pattern Error
10351	STM-1 #1 Overhead Pattern 1, Columns 2,5,8 - Fail to Sync	10352	STM-1 #1 Overhead Pattern 1,Columns 2,5,8 - Pattern Error
10361	STM-1 #1 Overhead Pattern 1, Columns 3,6,9 - Fail to Sync	10362	STM-1 #1 Overhead Pattern 1,Columns 3,6,9 - Pattern Error
10371	STM-1 #2 Overhead Pattern 1, Columns 1,4,7 - Fail to Sync	10372	STM-1 #2 Overhead Pattern 1,Columns 1,4,7 - Pattern Error
10381	STM-1 #2 Overhead Pattern 1, Columns 2,5,8 - Fail to Sync	10382	STM-1 #2 Overhead Pattern 1,Columns 2,5,8 - Pattern Error
10391	STM-1 #2 Overhead Pattern 1, Columns 3,6,9 - Fail to Sync	10392	STM-1 #2 Overhead Pattern 1,Columns 3,6,9 - Pattern Error
10401	STM-1 #3 Overhead Pattern 1, Columns 1,4,7 - Fail to Sync	10402	STM-1 #3 Overhead Pattern 1,Columns 1,4,7 - Pattern Error
10411	STM-1 #3 Overhead Pattern 1, Columns 2,5,8 - Fail to Sync	10412	STM-1 #3 Overhead Pattern 1,Columns 2,5,8 - Pattern Error
10421	STM-1 #3 Overhead Pattern 1, Columns 3,6,9 - Fail to Sync	10422	STM-1 #3 Overhead Pattern 1,Columns 3,6,9 - Pattern Error
10431	STM-1 #4 Overhead Pattern 1, Columns 1,4,7 - Fail to Sync	10432	STM-1 #4 Overhead Pattern 1,Columns 1,4,7 - Pattern Error
10441	STM-1 #4 Overhead Pattern 1, Columns 2,5,8 - Fail to Sync	10442	STM-1 #4 Overhead Pattern 1,Columns 2,5,8 - Pattern Error
10451	STM-1 #4 Overhead Pattern 1, Columns 3,6,9 - Fail to Sync	10452	STM-1 #4 Overhead Pattern 1,Columns 3,6,9 - Pattern Error
10461	STM-1 #1 Overhead Pattern 2, Columns 1,4,7 - Fail to Sync	10462	STM-1 #1 Overhead Pattern 2,Columns 1,4,7 - Pattern Error
10471	STM-1 #1 Overhead Pattern 2, Columns 2,5,8 - Fail to Sync	10472	STM-1 #1 Overhead Pattern 2,Columns 2,5,8 - Pattern Error
10481	STM-1 #1 Overhead Pattern 2, Columns 3,6,9 - Fail to Sync	10482	STM-1 #1 Overhead Pattern 2,Columns 3,6,9 - Pattern Error
10491	STM-1 #2 Overhead Pattern 2, Columns 1,4,7 - Fail to Sync	10492	STM-1 #2 Overhead Pattern 2,Columns 1,4,7 - Pattern Error

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No.	Description	No.	Description
10501	STM-1 #2 Overhead Pattern 2, Columns 2,5,8 - Fail to Sync	10502	STM-1 #2 Overhead Pattern 2,Columns 2,5,8 - Pattern Error
10511	STM-1 #2 Overhead Pattern 2, Columns 3,6,9 - Fail to Sync	10512	STM-1 #2 Overhead Pattern 2,Columns 3,6,9 - Pattern Error
10521	STM-1 #3 Overhead Pattern 2, Columns 1,4,7 - Fail to Sync	10522	STM-1 #3 Overhead Pattern 2,Columns 1,4,7 - Pattern Error
10531	STM-1 #3 Overhead Pattern 2, Columns 2,5,8 - Fail to Sync	10532	STM-1 #3 Overhead Pattern 2,Columns 2,5,8 - Pattern Error
10541	STM-1 #3 Overhead Pattern 2, Columns 3,6,9 - Fail to Sync	10542	STM-1 #3 Overhead Pattern 2,Columns 3,6,9 - Pattern Error
10551	STM-1 #4 Overhead Pattern 2, Columns 1,4,7 - Fail to Sync	10552	STM-1 #4 Overhead Pattern 2,Columns 1,4,7 - Pattern Error
10561	STM-1 #4 Overhead Pattern 2, Columns 2,5,8 - Fail to Sync	10562	STM-1 #4 Overhead Pattern 2,Columns 2,5,8 - Pattern Error
10571	STM-1 #4 Overhead Pattern 2, Columns 3,6,9 - Fail to Sync	10572	STM-1 #4 Overhead Pattern 2,Columns 3,6,9 - Pattern Error

Table 5-25STM-4 Alarms Options 130, 131

No.	Description	No.	Description
10591	1310 nm, No Frame Errors - OOF Alarm Test Fail	10592	1310 nm, No Frame Errors - LOF Alarm Test Fail
10601	1310 nm, 3 in 4 Frame Errors - OOF Alarm Test Fail	10602	1310 nm, 3 in 4 Frame Errors - LOF Alarm Test Fail
10611	1310 nm, No Alarms - Pattern Sync Loss	10622	1310 nm, MS-AIS Alarm - Alarm Not Detected
10632	1310 nm, No Alarms - MS-AIS Alarm	10641	1310 nm, No Alarms - Pattern Sync Loss
10652	1310 nm, MS-RDI Alarm - Alarm Not Detected	10662	1310 nm, No Alarms - MS-RDI Alarm

Table 5-26Binary Interface Options 0YH with 130 or 131

No.	Description	No.	Description
10701	STM-1 Binary - Signal Loss	10702	STM-1 Binary - Pattern Sync Loss
10711	STM-1 Binary, Error Add - Alarms Detected	10721	STM-1 Binary, Error Add - Pattern Sync Loss
10723	STM-1 Binary, Error Add - Bit Error Rate Low	10724	STM-1 Binary, Error Add - Bit Error Rate High
10731	STM-1 Binary, TX OFF - No Alarms	10732	STM-1 Binary, TX OFF - No Signal Loss
10751	STM-4 Binary, Error Add - No Alarms	10752	STM-4 Binary, Error Add - No Signal Loss
10761	STM-4 Binary, Error Add - Pattern Sync Loss	10763	STM-4 Binary, Error Add - Bit Error Rate Low
10764	STM-4 Binary, Error Add - Bit Error Rate High	10771	STM-4 Binary, TX OFF - No Alarms
10772	STM-4 Binary, TX OFF - No Signal Loss	10781	STM-4 Binary - Frame Sync Loss
10782	STM-4 Binary - B1 Errors	10792	STM-4 Binary - B2 Errors

Table 5-27 C	Optical Power Measurement	Options 130, 131

No.	Description	No.	Description
10801	1310 nm STM-1 - Alarm Sync	10803	1310 nm STM-1 - Result Low
10804	1310 nm STM-1 - Result High	10805	1550 nm STM-1 - Alarm Sync
10807	1550 nm STM-1 - Result Low	10808	1550 nm STM-1 - Result High
10811	1310 nm STM-4 - Alarm Sync	10813	1310 nm STM-4 - Result Low
10814	1310 nm STM-4 - Result High	10815	1550 nm STM-4 - Alarm Sync
10817	1550 nm STM-4 - Result Low	10818	1550 nm STM-4 - Result High

Table 5-28Frequency Measurement Options 130, 131

No.	Description	No.	Description
10821	1310 nm STM-1 - Loss Of Signal	10823	1310 nm STM-1 - Result Low
10824	1310 nm STM-1 - Result High	10825	1550 nm STM-1 - Loss Of Signal
10827	1550 nm STM-1 - Result Low	10828	1550 nm STM-1 - Result High
10831	1310 nm STM-4 - Loss Of Signal	10833	1310 nm STM-4 - Result Low
10834	1310 nm STM-4 - Result High	10835	1550 nm STM-4 - Loss Of Signal
10837	1550 nm STM-4 - Result Low	10838	1550 nm STM-4 - Result High

Table 5-29

Error Add Tests Options 130, 131

No.	Description	No.	Description
10841	1310 nm STM-4 B2 - Frame Sync Loss	10843	1310 nm STM-4 - B2 Error Rate Low
10844	1310 nm STM-4 - B2 Error Rate High	10853	1310 nm STM-4 - Frame Error Rate Low
10854	1310 nm STM-4 - Frame Error Rate High	10855	1310 nm STM-4 - B1 Error Rate Low
10856	1310 nm STM-4 - B1 Error Rate High	10857	1310 nm STM-4- MS FEBE//MS REI Error Rate
			Low
10858	1310 nm STM-4 - MS FEBE//MS REI Error Rate High		

Table 5-30STM-4 Stress Test Options 130, 131

No.	Description	No.	Description
10861	1310 nm - Frame Sync Loss	10862	1310 nm - OOF Alarm
10865	1550 nm - Frame Sync Loss	10866	1550 nm - OOF Alarm

Table 5-31Loss of Signal Tests Options 130, 131

No.	Description	No.	Description
10872	1310 nm - No Loss of Optical Signal	10873	1310 nm - Loss of Optical Signal
10876	1550 nm - No Loss of Optical Signal	10877	1550 nm - Loss of Optical Signal
10882	1310 nm - No Loss of Binary Signal	10883	1310 nm - Loss of Binary Signal
10886	1550 nm - No Loss of Binary Signal	10887	1550 nm - Loss of Binary Signal

Table 5-32STM-4c Tests Options 130, 131

No.	Description	No.	Description
10891	1310 nm - POH J1 Byte error	10901	1310 nm, PRBS 2 ²³ - Frame Sync Loss
10903	1310 nm, PRBS 2 ²³ - Error Rate Low	10904	1310 nm, PRBS 2 ²³ - Error Rate High
10911	1310 nm, PRBS 2 ¹⁵ - Frame Sync Loss	10913	1310 nm, PRBS 2 ¹⁵ - Error Rate Low
10914	1310 nm, PRBS 2 ¹⁵ - Error Rate High	10921	1310 nm, Word - Frame Sync Loss
10923	1310 nm, Word - Error Rate Low	10924	1310 nm,Word - Error Rate High
10931	1310 nm, PRBS 2 ⁹ - Frame Sync Loss	10933	1310 nm, PRBS 2 ⁹ - Error Rate Low
10934	1310 nm, PRBS 2 ⁹ - Error Rate High	10941	1310 nm, Frequency Offset - Frame Sync Loss
10942	1310 nm, Frequency Offset - Pointer Alarm	10943	1310 nm, Frequency Offset - B1 Bip Errors
10944	1310 nm, Frequency Offset - B2 Bip Errors	10945	1310 nm, Frequency Offset - B3 Bip Errors
10953	1310 nm, +100 ppm Offset - Result Low	10954	1310 nm, +100ppm Offset -Result High
10955	1310 nm, -100 ppm Offset - Result Low	10956	1310 nm, -100ppm Offset -Result High

Table 5-33	STM-4 Pavloads Tests	Options 130, 131
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No.	Description	No.	Description
10961	Background Payload - Frame Sync Loss	10962	Background Payload - Errors Detected
10971	F/G Payload STM-1 #1 - Frame Sync Loss	10972	F/G Payload STM-1 #1 - Error Count Wrong
10973	F/G Payload STM-1 #2 - Frame Sync Loss	10974	F/G Payload STM-1 #2 - Error Count Wrong
10975	F/G Payload STM-1 #4 - Frame Sync Loss	10976	F/G Payload STM-1 #4 - Error Count Wrong
10981	ThruMode-H4Frame Fail	10991	Overhead Processor Fail
10992	STM-1-POH Fail	10994	STM-1- SOH Fail
10995	Regenerator SOH DCC Fail	10996	Multiplexer SOH DCC Fail

Terminology

6

Tables of ETSI Terms with their ANSI equivalents and current terms with their equivalent earlier terms.

ETSI / ANSI Equivalent Terms

The Terminology used on the instrument display is mainly ETSI terminology. The equivalent ANSI terminology is given in the following table

ETSI Term	ANSI Term	
I-n Intra Office, STM-n	Intermediate Reach (IR)	
L-n.1 or L-n.2 long haul	LR long reach	
Multiplexer Section (MS)	Line	
MS-AIS	AIS-L (Line AIS)	
MS-BIP	Line BIP	
MS-DCC	Line DCC	
MS-RD (MS FERF)	RDI-L (Line FERF)	
Multiplexer Section Overhead	Line Overhead	
Network Node Interface	Line Interface	
AU-AIS (Path AIS)	AIS-P	
HP-RDI (Path FERF)	RDI-P	
Regenerator	Repeater	
Regenerator Section (RS)	Section	
Remote Alarm Indicator	Yellow Alarm	
Regenerator Section Overhead	Section Overhead	
RS-DCC	Section DCC	
S-n.1 or S-n.2 short haul	Short Reach (SR)	
STM-n	STS-n	
SOH	ТОН	
Section Overhead (SOH)	Transport Overhead (TOH)	
Tributary Unit (TU)	Virtual Tributary (VT)	

Terminology ETSI / ANSI Equivalent Terms

ETSI Term	ANSI Term
TU	VT
TU-AIS	VT AIS (AIS-V)
TU FERF / TU RDI	RDI-V / VT FERF
TU REI	VT FEBE
VC	SPE
Virtual Container	Payload Envelope
Virtual Container (VC)	Synchronous Payload Envelope (SPE)
VP-RDI (VP-FERF)	VP-RDI
VC-RDI (VC-FERF)	VC-RDI

NOTE: VC is an ETSI abbreviation for Virtual Container and an ETSI / ANSI abbreviation for (ATM) Virtual Channel. The context of VC must therefore be taken into account when converting between standards.

Current / Previous Terminology

Current Terminology	Previous Terminology	
B1 BIP	RS B1 BIP	
B2 BIP	MS B2 BIP	
B3 BIP	Path B3 BIP	
MS-AIS	MS AIS	
MS-RDI	MS RDI	
MS-REI	MS FEBE	
HP-IEC	Path IEC	
AU-LOP	LOP	
AU-AIS	Path AIS	
HP-RDI	Path FERF	
HP-REI	Path FEBE	
TU-LOP	TU LOP	
TU-AIS	TU Path AIS	
LP-RDI	TU Path FERF	
LP-REI	TU Path FEBE	

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In This Book

This book provides information on HP 37717C modules with SDH capability. It also provides applications associated with these modules. The individual applications contain techniques which may be of value for purposes other than those shown



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